



TEST REPORT

Test report no.: 1-4262/17-01-02-A



Testing laboratory

CTC advanced GmbH

Untertuerkheimer Strasse 6 – 10

66117 Saarbruecken / Germany

Phone: + 49 681 5 98 - 0

Fax: + 49 681 5 98 - 9075

Internet: <http://www.ctcadvanced.com>

e-mail: mail@ctcadvanced.com

Accredited Testing Laboratory:

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-01

Applicant

Sick AG

Erwin-Sick-Str. 1

79183 Waldkirch / GERMANY

Phone: +49 (0) 7681 2020

Fax: +49 7681 202-3600

Contact: Wolfgang Hettich

e-mail: Wolfgang.Hettich@sick.de

Phone: +49 7681 202-5925

Manufacturer

Sick AG

Erwin-Sick-Str. 1

79183 Waldkirch / GERMANY

47 CFR Part 15

Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices

RSS - 247 Issue 2

Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices

RSS - Gen Issue 4

Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

For further applied test standards please refer to section 3 of this test report.

Test standard/s

47 CFR Part 15

Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices

RSS - 247 Issue 2

Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices

RSS - Gen Issue 4

Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

Test Item

Kind of test item: Photoelectric sensor

Model name: WLG16

FCC ID: 2AHDR-W16

IC: 21147-W16

Frequency: DTS band 2400 MHz to 2483.5 MHz

Technology tested: Bluetooth® LE

Antenna: Integrated antenna

Power supply: 24.0 V DC by external power supply

Temperature range: -40°C to +60°C



This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorized:

p.o.

Stefan Bös
Lab Manager
Radio Communications & EMC

Test performed:

Mihail Dorongovskij
Lab Manager
Radio Communications & EMC

1 Table of contents

1	Table of contents	2
2	General information	3
2.1	Notes and disclaimer	3
2.2	Application details	3
2.3	Test laboratories sub-contracted	3
3	Test standard/s and references	4
4	Test environment	5
5	Test item	5
5.1	General description	5
5.2	Additional information	5
6	Sequence of testing	6
6.1	Sequence of testing radiated spurious 9 kHz to 30 MHz	6
6.2	Sequence of testing radiated spurious 30 MHz to 1 GHz	7
6.3	Sequence of testing radiated spurious 1 GHz to 18 GHz	8
6.4	Sequence of testing radiated spurious above 18 GHz	9
7	Measurement uncertainty	10
8	Description of the test setup	11
8.1	Shielded semi anechoic chamber	12
8.2	Shielded fully anechoic chamber	13
8.3	Radiated measurements > 18 GHz	14
8.4	Conducted measurements C.BER system	15
8.5	AC conducted	16
9	Summary of measurement results	17
10	Additional comments	18
11	Measurement results	19
11.1	Power spectral density	19
11.2	DTS bandwidth – 6 dB bandwidth	22
11.3	Occupied bandwidth – 99% emission bandwidth	25
11.4	Maximum output power	28
11.5	Detailed spurious emissions @ the band edge - conducted	31
11.6	Band edge compliance radiated	33
11.7	TX spurious emissions conducted	35
11.8	Spurious emissions radiated below 30 MHz	38
11.9	Spurious emissions radiated 30 MHz to 1 GHz	41
11.10	Spurious emissions radiated above 1 GHz	46
11.11	Spurious emissions conducted below 30 MHz (AC conducted)	53
12	Observations	56
Annex A	Glossary	56
Annex B	Document history	57
Annex C	Accreditation Certificate	57

2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CTC advanced GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

The test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of CTC advanced GmbH.

The testing service provided by CTC advanced GmbH has been rendered under the current "General Terms and Conditions for CTC advanced GmbH".

CTC advanced GmbH will not be liable for any loss or damage resulting from false, inaccurate, inappropriate or incomplete product information provided by the customer.

Under no circumstances does the CTC advanced GmbH test report include any endorsement or warranty regarding the functionality, quality or performance of any other product or service provided.

Under no circumstances does the CTC advanced GmbH test report include or imply any product or service warranties from CTC advanced GmbH, including, without limitation, any implied warranties of merchantability, fitness for purpose, or non-infringement, all of which are expressly disclaimed by CTC advanced GmbH.

All rights and remedies regarding vendor's products and services for which CTC advanced GmbH has prepared this test report shall be provided by the party offering such products or services and not by CTC advanced GmbH. In no case this test report can be considered as a Letter of Approval.

This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

This test report replaces the test report with the number 1-4262/17-01-02 and dated 2017-08-08.

2.2 Application details

Date of receipt of order:	2017-06-01
Date of receipt of test item:	2017-07-05
Start of test:	2017-07-10
End of test:	2017-07-18
Person(s) present during the test:	-/-

2.3 Test laboratories sub-contracted

None

3 Test standard/s and references

Test standard	Date	Description
47 CFR Part 15		Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 247 Issue 2	February 2017	Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices
RSS - Gen Issue 4	November 2014	Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

Guidance	Version	Description
DTS: KDB 558074 D01	V04	Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247
ANSI C63.4-2014	-/-	American national standard for methods of measurement of radio-noise emissions from low-voltage electrical and electronic equipment in the range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American national standard of procedures for compliance testing of unlicensed wireless devices

4 Test environment

Temperature	: T _{nom} T _{max} T _{min}	+22 °C during room temperature tests No tests under extreme conditions required. No tests under extreme conditions required.
Relative humidity content	: 55 %	
Barometric pressure	: 1021 hpa	
Power supply	: V _{nom} V _{max} V _{min}	24.0 V DC by external power supply No tests under extreme conditions required. No tests under extreme conditions required.

5 Test item

5.1 General description

Kind of test item	: Photoelectric sensor
Type identification	: WLG16
HMN	: -/
PMN	: WLG16 Bluetooth
HVIN	: WLG16P-2416212BA00
FVIN	: -/
S/N serial number	: 17190038AB
HW hardware status	: 0.3.1D
SW software status	: 0.3.1D
Frequency band	: DTS band 2400 MHz to 2483.5 MHz (lowest channel 2402 MHz; highest channel 2480 MHz)
Type of radio transmission	: DSSS
Use of frequency spectrum	: DSSS
Type of modulation	: GFSK
Number of channels	: 40
Antenna	: Integrated antenna
Power supply	: 24.0 V DC by external power supply
Temperature range	: -40°C to +60°C

5.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report:

1-1163/16-01-01_AnnexA

1-4262/17-01-01_AnnexB

1-4262/17-01-01_AnnexD

6 Sequence of testing

6.1 Sequence of testing radiated spurious 9 kHz to 30 MHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premereasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1.5 m.
- At each turntable position the analyzer sweeps with positive-peak detector to find the maximum of all emissions.

Final measurement

- Identified emissions during the premeasurement are maximized by the software by rotating the turntable from 0° to 360°. In case of the 2-axis positioner is used the elevation axis is also rotated from 0° to 360°.
- The final measurement is done in the position (turntable and elevation) causing the highest emissions with quasi-peak (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. A plot with the graph of the premeasurement and the limit is stored.

6.2 Sequence of testing radiated spurious 30 MHz to 1 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 10 m or 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premereasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 m to 3 m.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximize the peaks by changing turntable position $\pm 45^\circ$ and antenna height between 1 and 4 m.
- The final measurement is done with quasi-peak detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

6.3 Sequence of testing radiated spurious 1 GHz to 18 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premereasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height is 1.5 m.
- At each turntable position and antenna polarization the analyzer sweeps with positive peak detector to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximizes the peaks by rotating the turntable from 0° to 360°. This measurement is repeated for different EUT-table positions (0° to 150° in 30°-steps) and for both antenna polarizations.
- The final measurement is done in the position (turntable, EUT-table and antenna polarization) causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, EUT-table position, antenna polarization, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

6.4 Sequence of testing radiated spurious above 18 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet.
- The measurement distance is as appropriate (e.g. 0.5 m).
- The EUT is set into operation.

Premeasurement

- The test antenna is handheld and moved carefully over the EUT to cover the EUT's whole sphere and different polarizations of the antenna.

Final measurement

- The final measurement is performed at the position and antenna orientation causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement and the limit is stored.

7 Measurement uncertainty

Measurement uncertainty	
Test case	Uncertainty
Antenna gain	± 3 dB
Spectrum bandwidth	± 21.5 kHz absolute; ± 15.0 kHz relative
Maximum output power	± 1 dB
Detailed conducted spurious emissions @ the band edge	± 1 dB
Band edge compliance radiated	± 3 dB
Spurious emissions conducted	± 3 dB
Spurious emissions radiated below 30 MHz	± 3 dB
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB
Spurious emissions radiated 1 GHz to 12.75 GHz	± 3.7 dB
Spurious emissions radiated above 12.75 GHz	± 4.5 dB
Spurious emissions conducted below 30 MHz (AC conducted)	± 2.6 dB

8 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

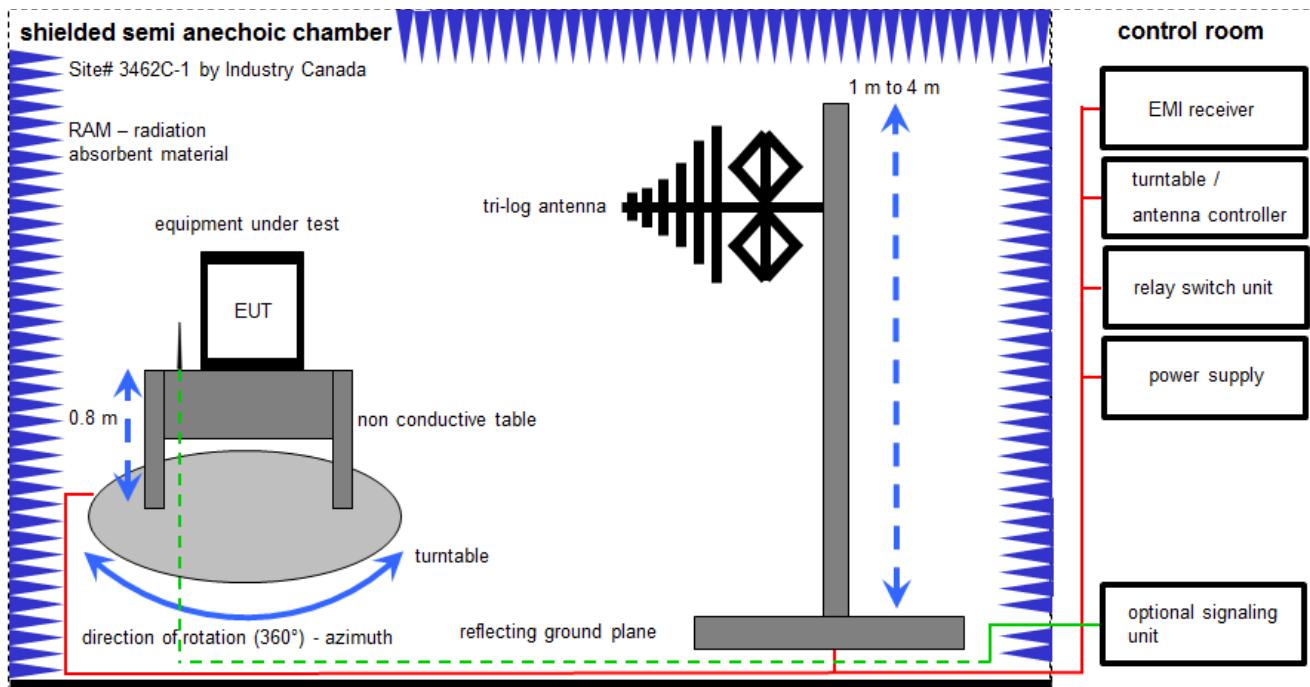
In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
VLK!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

8.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are conform to specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Measurement distance: tri-log antenna 10 meter

$$FS = UR + CL + AF$$

(FS-field strength; UR-voltage at the receiver; CL-loss of the cable; AF-antenna factor)

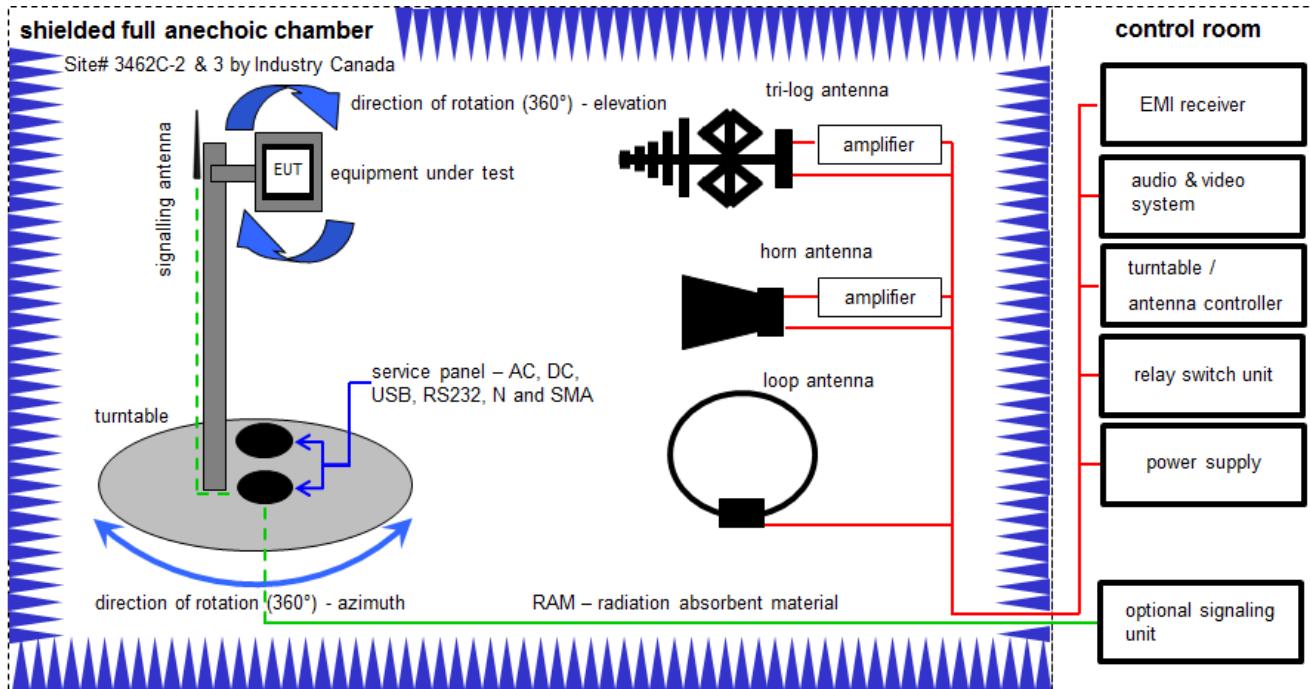
Example calculation:

$$FS [\text{dB}\mu\text{V}/\text{m}] = 12.35 [\text{dB}\mu\text{V}/\text{m}] + 1.90 [\text{dB}] + 16.80 [\text{dB}/\text{m}] = 31.05 [\text{dB}\mu\text{V}/\text{m}] (35.69 \mu\text{V}/\text{m})$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch-Unit	3488A	HP	2719A14505	300000368	ev	-/-	-/-
2	A	Meßkabine 1	HF-Absorberhalle	MWB AG 300023	101042	300000551	ne	-/-	-/-
3	A	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	01.02.2017	31.01.2018
4	A	Analyser-Reference-System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	Ve	02.02.2016	02.02.2018
5	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
6	A	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw	-/-	-/-
7	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
8	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	25.04.2016	25.04.2018

8.2 Shielded fully anechoic chamber



Measurement distance: tri-log antenna and horn antenna 3 meter; loop antenna 3 meter

FS = UR + CA + AF

(FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

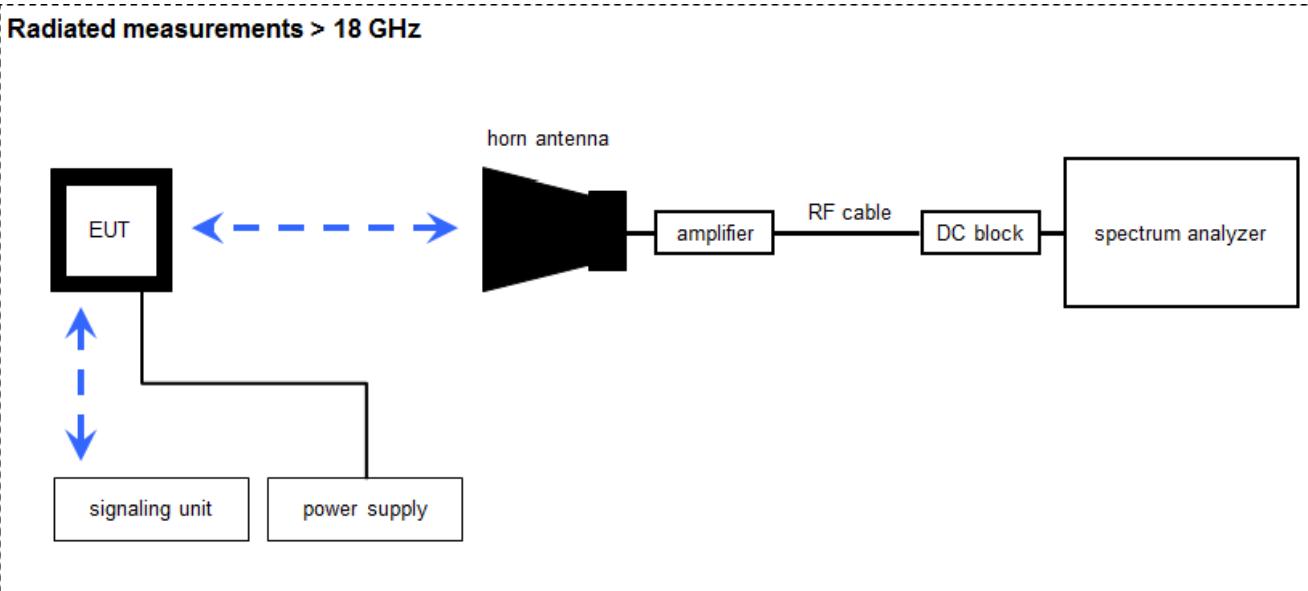
Example calculation:

FS [dB μ V/m] = 40.0 [dB μ V/m] + (-35.8) [dB] + 32.9 [dB/m] = 37.1 [dB μ V/m] (71.61 μ V/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	C	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO	2210	300001015	k	20.05.2017	20.05.2019
2	A	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	9709-5290	300000212	k	13.08.2015	13.08.2017
3	A	Highpass Filter WHK1.1/15G-10SS	Wainwright	37	400000148	ne	-/-	-/-	-/-
4	A	Highpass Filter WHK7.0/18G-8SS	Wainwright	18	300003789	ne	-/-	-/-	-/-
5	A	Band Reject Filter WRCG2400/2483-2375/2505-50/10SS	Wainwright	26	300003792	ne	-/-	-/-	-/-
6	A, B	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	371	300003854	vIKI!	29.10.2014	29.10.2017
7	A, B	Broadband Amplifier 0.5-18 GHz	CBLU5184540	CERNEX	22051	300004483	ev	-/-	-/-
8	A, B, C	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000032	300004510	ne	-/-	-/-
9	A, B, C	Messrechner und Monitor	Intel Core i3 3220/3,3 GHz, Prozessor	Huber & Suhner	2V2403033A54 21	300004591	ne	-/-	-/-
10	A, B, C	NEXIO EMC-Software	BAT EMC V3.16.0.49	EMCO	Batch no. 14844	300004682	ne	-/-	-/-
11	A, B, C	Anechoic chamber	ESH3-Z5	TDK	893045/004	300003726	ne	-/-	-/-
12	A, B, C	EMI Test Receiver 9kHz-26,5GHz	ESR26	R&S	101376	300005063	vIKI!	13.09.2016	13.03.2018

8.3 Radiated measurements > 18 GHz



Measurement distance: horn antenna 50 cm

$$FS = U_R + CA + AF$$

(FS-field strength; U_R -voltage at the receiver; CA-loss signal path & distance correction; AF-antenna factor)

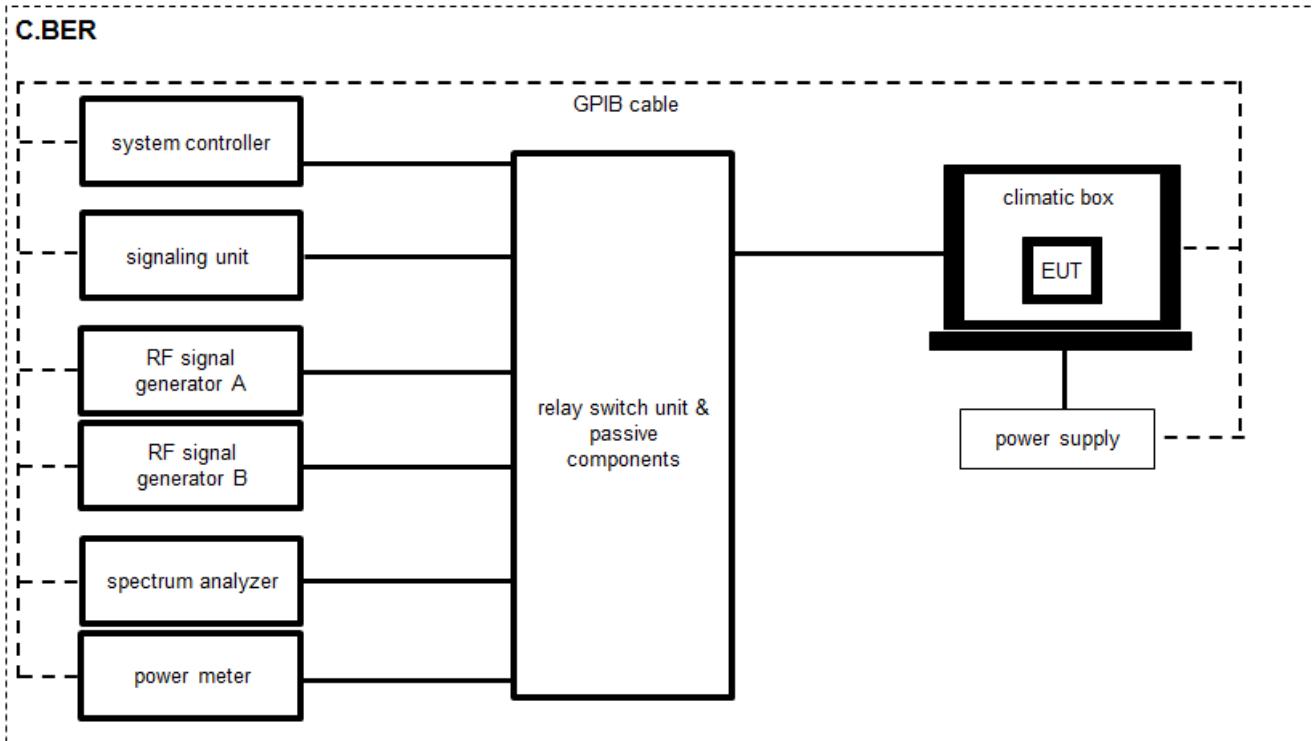
Example calculation:

$$FS [dB\mu V/m] = 40.0 [dB\mu V/m] + (-60.1) [dB] + 36.74 [dB/m] = 16.64 [dB\mu V/m] (6.79 \mu V/m)$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Std. Gain Horn Antenna 18.0 to 26.5 GHz	638	Narda	-/-	300000486	k	10.09.2015	10.09.2017
2	A	Signal Analyzer 40 GHz	FSV40	R&S	101042	300004517	k	27.01.2017	26.01.2018
3	A	Microwave System Amplifier, 0.5-26.5 GHz	83017A	HP	00419	300002268	ev	-/-	-/-
4	A	RF-Cable	ST18/SMAm/SMAm/48	Huber & Suhner	Batch no. 600918	400001182	ev	-/-	-/-
5	A	RF-Cable	ST18/SMAm/SMAm/48	Huber & Suhner	Batch no. 127377	400001183	ev	-/-	-/-
6	A	DC-Blocker 0.1-40 GHz	8141A	Inmet	-/-	400001185	ev	-/-	-/-

8.4 Conducted measurements C.BER system



OP = AV + CA
 (OP-output power; AV-analyzer value; CA-loss signal path)

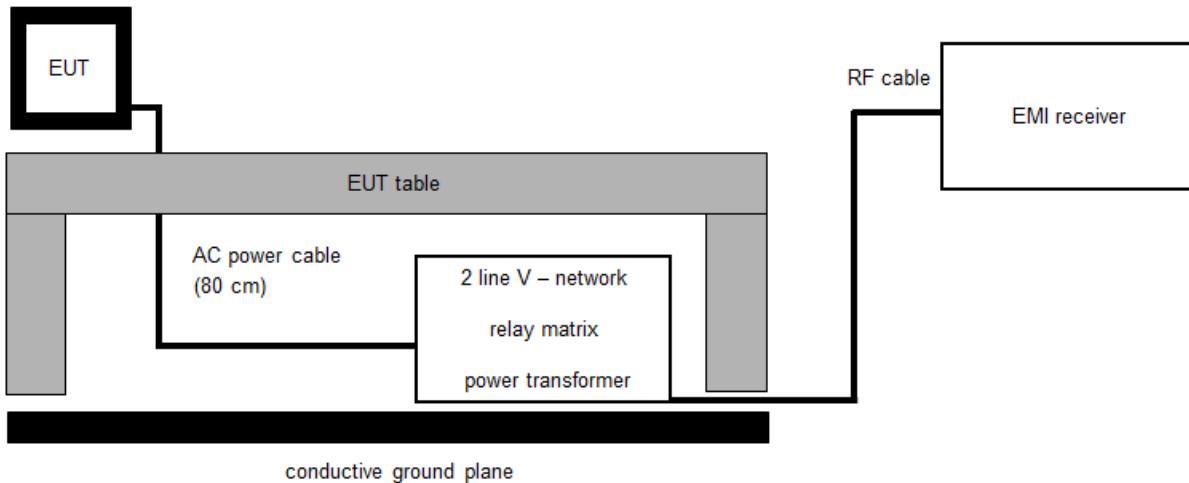
Example calculation:
 OP [dBm] = 6.0 [dBm] + 11.7 [dB] = 17.7 [dBm] (58.88 mW)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch / Control Unit	3488A	HP	-/-	300000929	ne	-/-	-/-
2	A	USB/GPIB interface	82357B	Agilent Technologies	MY52103346	300004390	ne	-/-	-/-
3	A	Signal Analyzer 30GHz	FSV30	R&S	103170	300004855	k	30.01.2017	29.01.2019
4	A	DC-Blocker	8143	Inmet Corp.	none	300002842	ne	-/-	-/-
5	A	Powersplitter	6005-3	Inmet Corp.	-/-	300002841	ev	-/-	-/-
6	A	Messplatzrechner	Tecline	F+W	-/-	300003580	ne	-/-	-/-
7	A	RF-Cable	ST18/SMAm/SMAm/72	Huber & Suhner	Batch no. 605505	400001187	ev	-/-	-/-
8	A	RF-Cable	Sucoflex 104	Huber & Suhner	147636/4	400001188	ev	-/-	-/-
9	A	Power Supply	NGSM 32/10	R&S	3939	400000192	vIKI!	31.01.2017	30.01.2020
10	A	Shielding Box	JRE2218	JRE Test LLC	0001110	400001265	ne	-/-	-/-

8.5 AC conducted

AC conducted



FS = UR + CF + VC

(FS-field strength; UR-voltage at the receiver; CR-loss of the cable and filter; VC-correction factor of the ISN)

Example calculation:

$$FS [dB\mu V/m] = 37.62 [dB\mu V/m] + 9.90 [dB] + 0.23 [dB] = 47.75 [dB\mu V/m] (244.06 \mu V/m)$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Two-line V-Network (LISN) 9 kHz to 30 MHz	ESH3-Z5	R&S	893045/004	300000584	k	31.01.2017	30.01.2018
2	A	RF-Filter-section	85420E	HP	3427A00162	300002214	k	27.11.2006	-/-
3	A	EM-Injection Clamp	FCC-203i	emv	232	300000626	ev	18.05.2001	-/-
4	A	AC- Spannungsquelle variabel	MV2616-V	EM-Test	0397-12	300003259	k	11.12.2015	11.12.2017
5	A	Hochpass 150 kHz	EZ-25	R&S	100010	300003798	ev	08.04.2008	-/-
6	A	MXE EMI Receiver 20 Hz to 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	k	16.08.2016	16.08.2017

9 Summary of measurement results

<input checked="" type="checkbox"/>	No deviations from the technical specifications were ascertained
<input type="checkbox"/>	There were deviations from the technical specifications ascertained
<input type="checkbox"/>	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS - 247, Issue 2	See table!	2017-11-29	-/-

Test specification clause	Test case	Guideline	Temperature conditions	Power source voltages	Mode	C	NC	NA	NP	Remark
§15.247(b)(4) RSS - 247 / 5.4 (4)	System gain	-/-	Nominal	Nominal	GFSK	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>	-/-
§15.247(e) RSS - 247 / 5.2 (b)	Power spectral density	KDB 558074 DTS clause: 10.6	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	*1
§15.247(a)(2) RSS - 247 / 5.2 (a)	DTS bandwidth - 6 dB bandwidth	KDB 558074 DTS clause: 8.1	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	*1
RSS Gen clause 4.6.1	Occupied bandwidth	-/-	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	*1
§15.247(b)(3) RSS - 247 / 5.4 (4)	Maximum output power	KDB 558074 DTS clause: 9.1.1	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	*1
§15.247(d) RSS - 247 / 5.5	Detailed spurious emissions @ the band edge - conducted	-/-	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	*1
§15.205 RSS - 247 / 5.5 RSS - Gen	Band edge compliance radiated	KDB 558074 DTS clause: 13.3.2	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(d) RSS - 247 / 5.5	TX spurious emissions conducted	KDB 558074 DTS clause: 11.1 & 11.2 11.3	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	*1
§15.209(a) RSS - Gen	Spurious emissions radiated below 30 MHz	-/-	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
15.247(d) RSS - 247 / 5.5 §15.109 RSS - Gen	Spurious emissions radiated 30 MHz to 1 GHz	-/-	Nominal	Nominal	-/-	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(d) RSS - 247 / 5.5 §15.109 RSS - Gen	Spurious emissions radiated above 1 GHz	-/-	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.107(a) §15.207	Conducted emissions below 30 MHz (AC conducted)	-/-	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-

*1): NOTE: The tests were performed with a radiated sample with the output power normalized to the E.I.R.P values which were measured at the anechoic chamber.

Note: C = Compliant; NC = Not compliant; NA = Not applicable; NP = Not performed

10 Additional comments

The Bluetooth® word mark and logos are owned by the Bluetooth SIG Inc. and any use of such marks by CTC advanced GmbH is under license.

Reference documents: 1-1163/16-01-01_AnnexA

Special test descriptions: A radiated sample was used for the conducted measurements. The values were normalized to E.I.R.P values which were measured at the anechoic chamber

Configuration descriptions: TX tests: were performed with LE packets (37 byte payload) and static PRBS pattern.
RX/Standby tests: BT enabled, TX Idle
Tested frequencies: lowest: 2402 MHz
middle: 2440 MHz
- highest: 2480 MHz

Test mode:

- Bluetooth LE Test mode enabled
(EUT is controlled over CBT)
- Special software is used.
EUT is transmitting pseudo random data by itself

Antennas and transmit operating modes:

- Operating mode 1 (single antenna)
 - *Equipment with 1 antenna,*
 - *Equipment with 2 diversity antennas operating in switched diversity mode by which at any moment in time only 1 antenna is used,*
 - *Smart antenna system with 2 or more transmit/receive chains, but operating in a mode where only 1 transmit/receive chain is used)*
- Operating mode 2 (multiple antennas, no beamforming)
 - *Equipment operating in this mode contains a smart antenna system using two or more transmit/receive chains simultaneously but without beamforming.*
- Operating mode 3 (multiple antennas, with beamforming)
 - *Equipment operating in this mode contains a smart antenna system using two or more transmit/receive chains simultaneously with beamforming.
In addition to the antenna assembly gain (G), the beamforming gain (Y) may have to be taken into account when performing the measurements.*

11 Measurement results

11.1 Power spectral density

Description:

Measurement of the power spectral density of a digital modulated system.

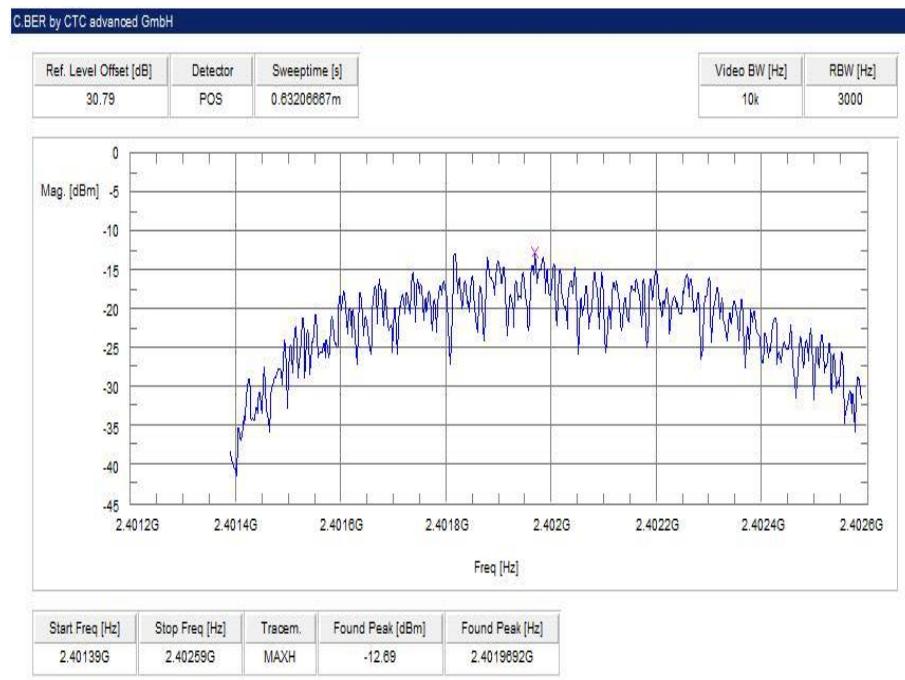
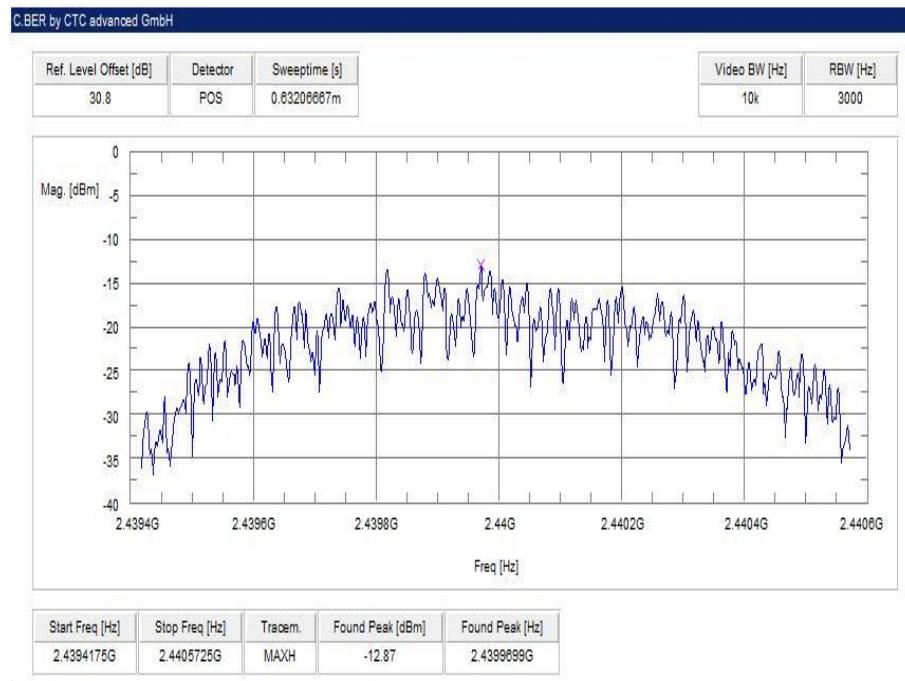
Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	3 kHz
Video bandwidth	10 kHz
Span	≥ EBW
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

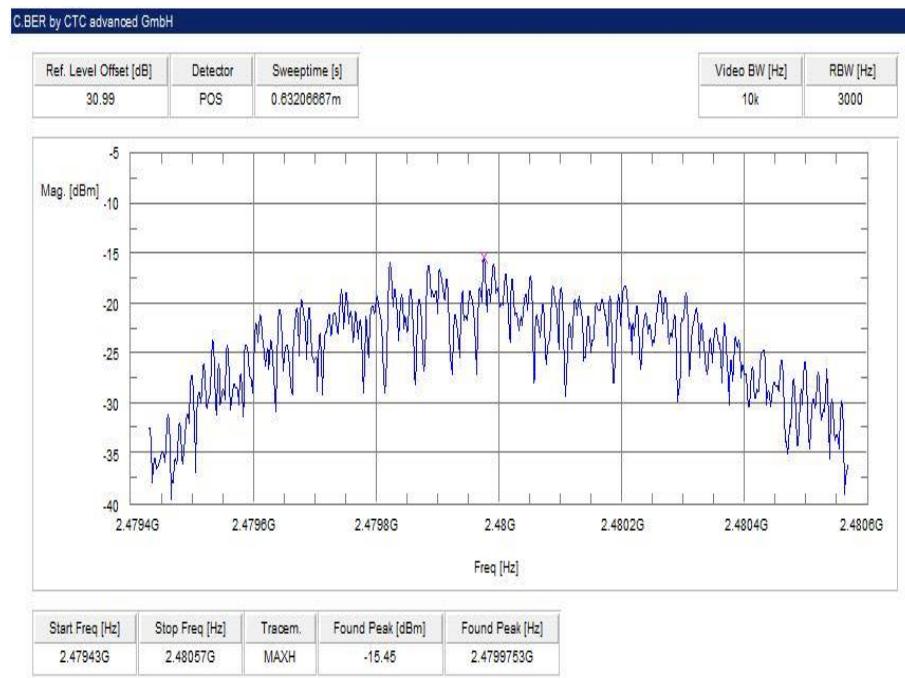
Limits:

FCC	IC
Power spectral density	
For digitally modulated systems the transmitter power spectral density conducted from the transmitter to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission or over 1.0 second if the transmission exceeds 1.0-second duration.	

Results:

	Frequency		
	2402 MHz	2440 MHz	2480 MHz
Power spectral density [dBm / 3kHz]	-12.7	-12.9	-15.5

Plots:**Plot 1: lowest channel****Plot 2: mid channel**

Plot 3: highest channel

11.2 DTS bandwidth – 6 dB bandwidth

Description:

Measurement of the 6 dB bandwidth of the modulated signal.

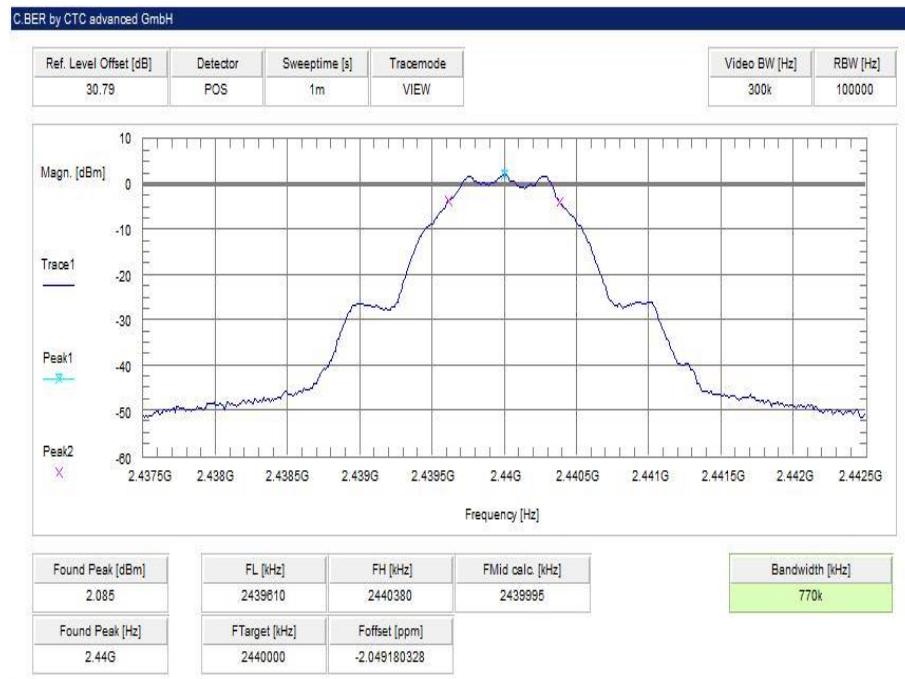
Measurement parameters	
According to DTS clause: 8.1	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz
Span	5 MHz
Measurement procedure	Using 3 marker (max + 2x-6dB)
Trace mode	Max hold (allow trace to stabilize)
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

FCC	IC
DTS bandwidth – 6 dB bandwidth	
Systems using digital modulation techniques may operate in the 2400–2483.5 MHz band. The minimum 6 dB bandwidth shall be at least 500 kHz.	

Results:

	Frequency		
	2402 MHz	2440 MHz	2480 MHz
6 dB bandwidth [kHz]	800	770	760

Plots:**Plot 1: lowest channel****Plot 2: mid channel**

Plot 3: highest channel

11.3 Occupied bandwidth – 99% emission bandwidth

Description:

Measurement of the 99% bandwidth of the modulated signal acc. RSS-GEN.

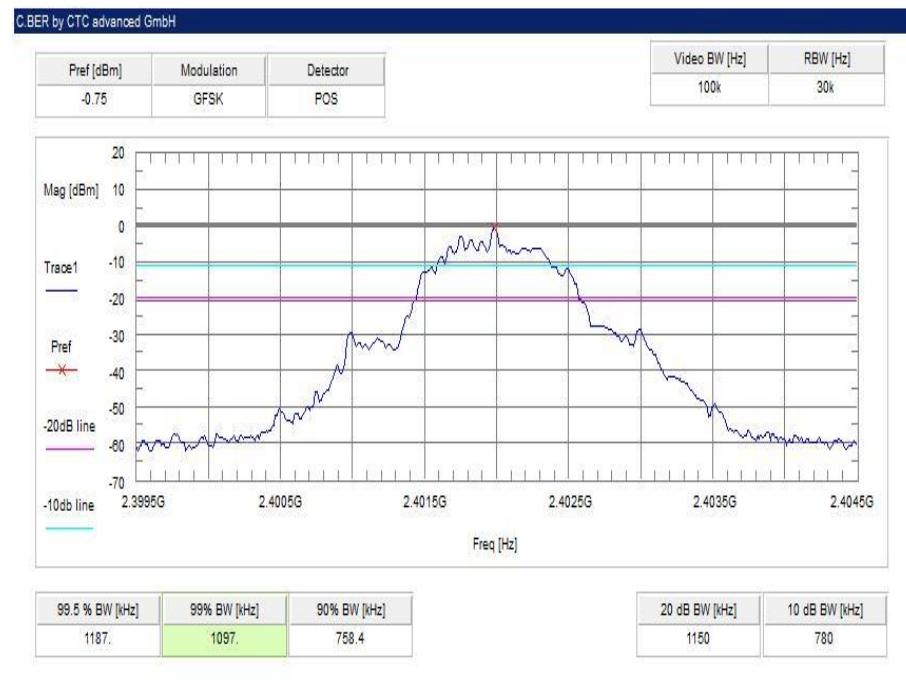
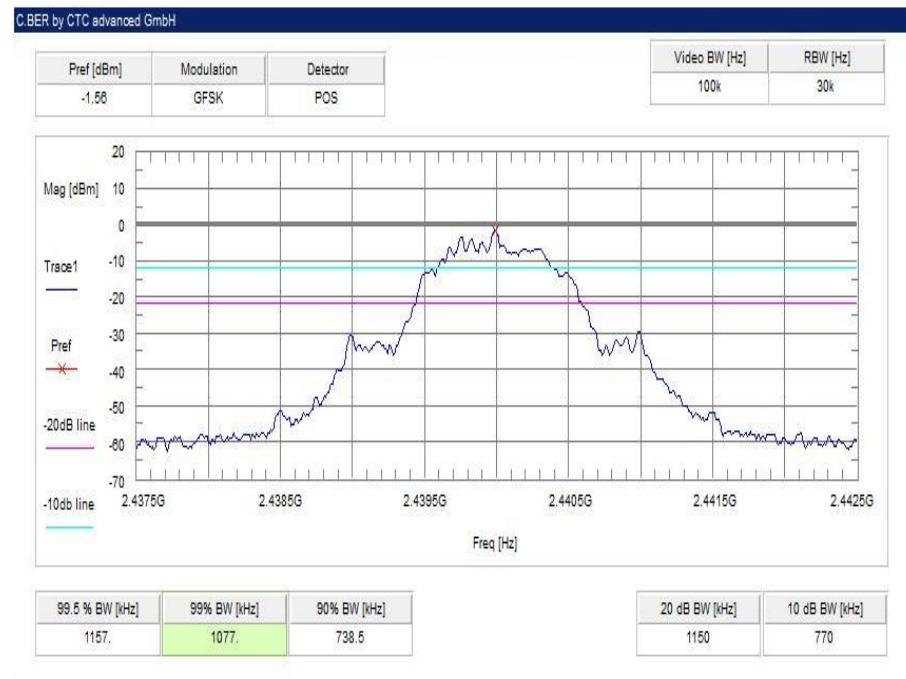
Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	30 kHz
Video bandwidth	100 kHz
Span	5 MHz
Measurement procedure	Measurement of the 99% bandwidth using the integration function of the analyzer
Trace mode	Max hold (allow trace to stabilize)
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

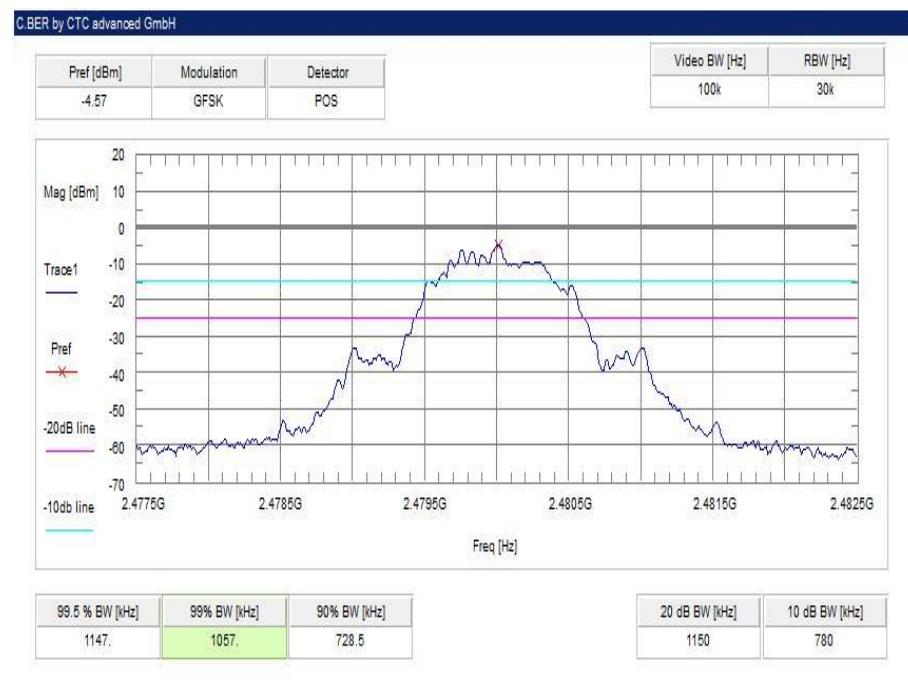
Usage:

-/-	IC
Occupied bandwidth – 99% emission bandwidth	
OBW is necessary for emission designator	

Results:

	Frequency		
	2402 MHz	2440 MHz	2480 MHz
99% bandwidth [kHz]	1097	1077	1057

Plots:**Plot 1: lowest channel****Plot 2: mid channel**

Plot 3: highest channel

11.4 Maximum output power

Description:

Measurement of the maximum output power conducted and radiated. EUT in single channel mode.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	3 MHz
Video bandwidth	10 MHz
Span	10 MHz
Trace mode	Max hold
Test setup	See sub clause 6.2 B
Measurement uncertainty	See sub clause 8

Limits:

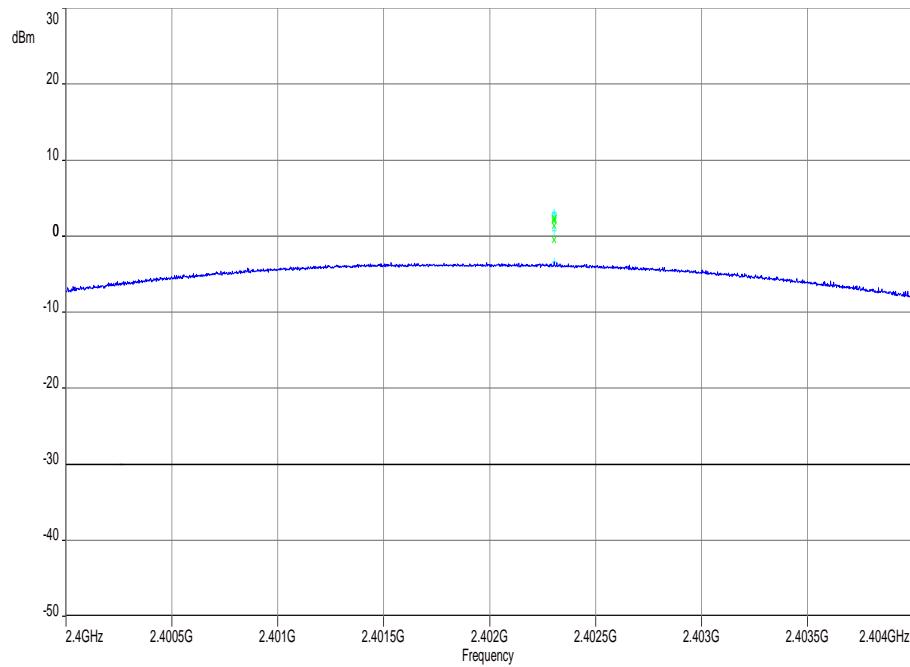
FCC	IC
Maximum output power	
[Conducted: 0.125 W – antenna gain max. 6 dBi] Systems using more than 75 hopping channels: Conducted: 1.0 W – antenna gain max. 6 dBi	

Results:

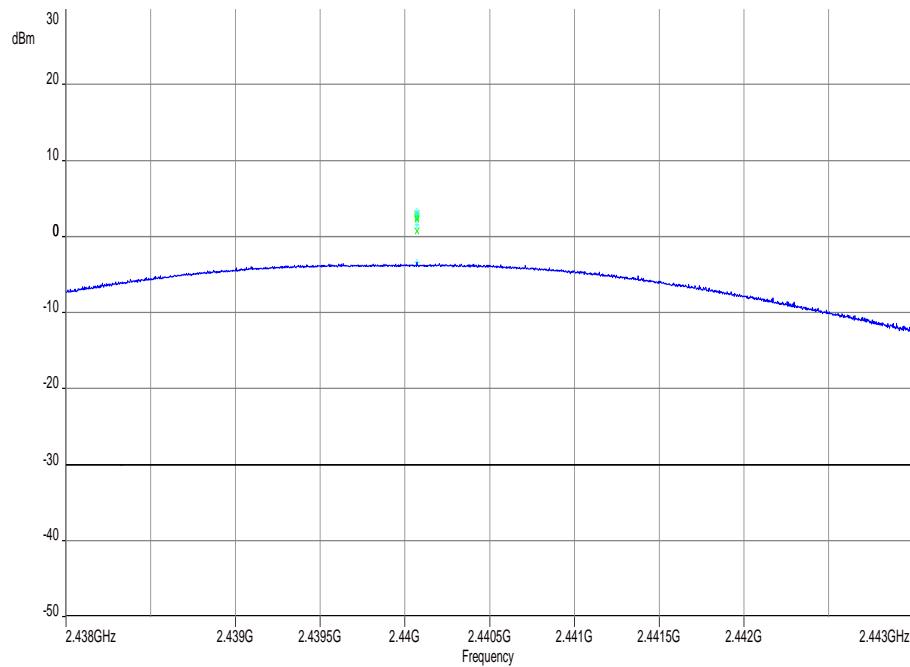
	Frequency		
	2402 MHz	2440 MHz	2480 MHz
Maximum output power conducted [dBm]	3.1	3.3	4.3

Plots:

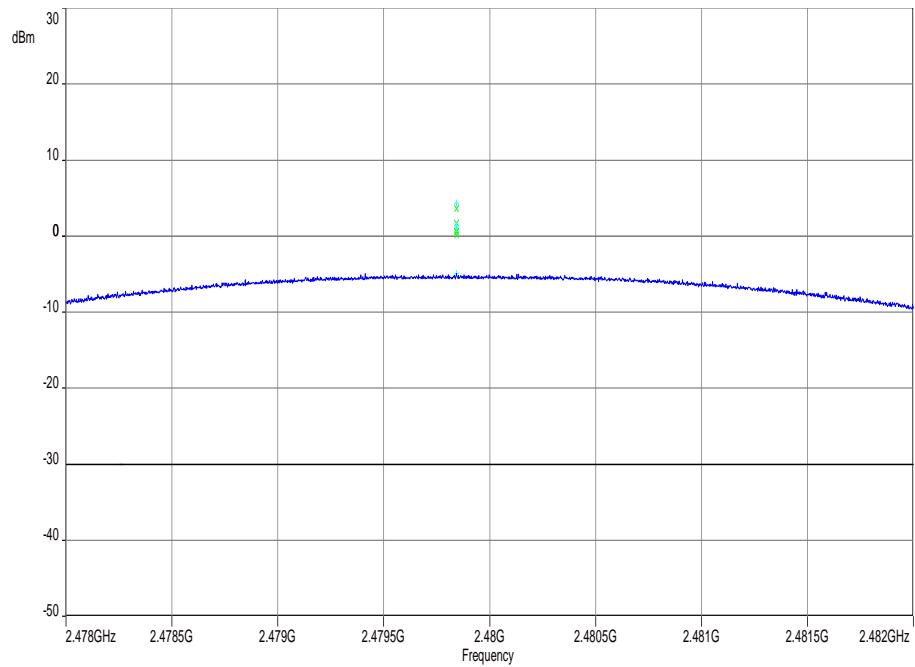
Plot 1: lowest channel



Plot 2: mid channel



Plot 3: highest channel



11.5 Detailed spurious emissions @ the band edge - conducted

Description:

Measurement of the conducted band edge compliance. EUT is measured at the lower and upper band edge in single channel.

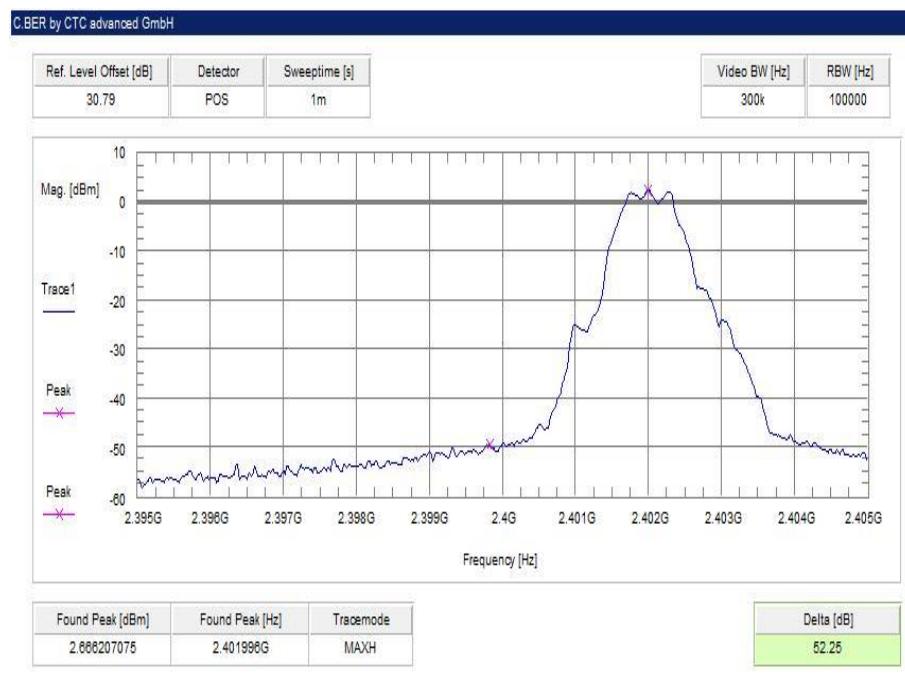
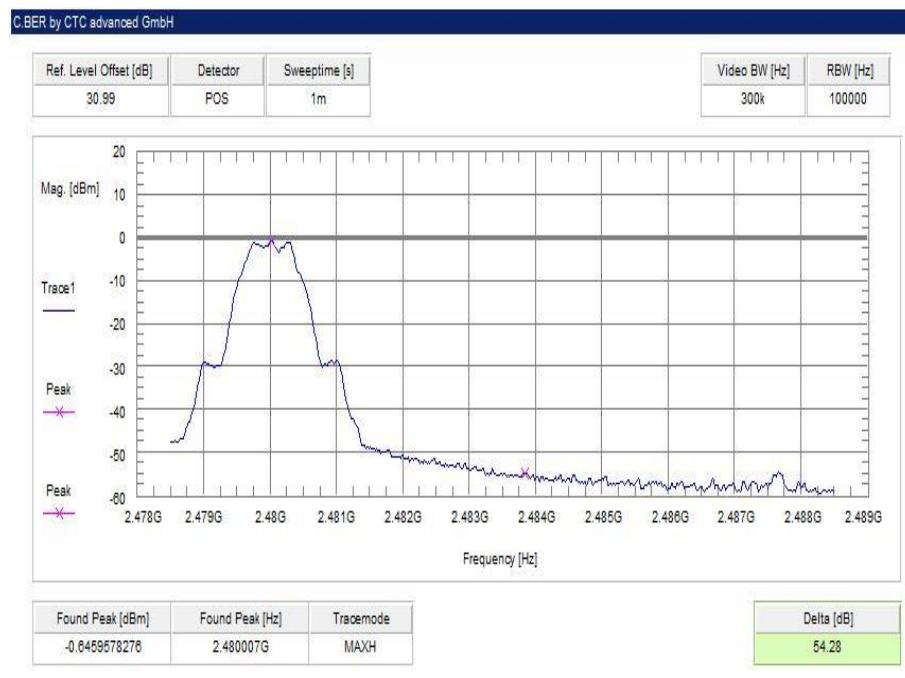
Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz / 500 kHz
Span	Lower Band Edge: 2395 – 2405 MHz Upper Band Edge: 2478 – 2489 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

FCC	IC
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required.	

Result:

Scenario	Spurious band edge conducted [dB]
	GFSK
Lower band edge – hopping off	> 20 dB
Upper band edge – hopping off	> 20 dB

Plots:**Plot 1: Lower band edge****Plot 2: Upper band edge**

11.6 Band edge compliance radiated

Description:

Measurement of the radiated band edge compliance. The EUT is turned in the position that results in the maximum level at the band edge. Then a sweep over the corresponding restricted band is performed. The EUT is set to single channel mode and the transmit frequency 2402 MHz for the lower restricted band and 2480 MHz for the upper restricted band. Measurement distance is 3m.

Measurement parameters	
Detector	Peak / RMS
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 MHz
Span	Lower Band: 2300 – 2400 MHz Upper Band: 2480 – 2500 MHz
Trace mode	Max hold
Test setup	See sub clause 6.2 B
Measurement uncertainty	See sub clause 8

Limits:

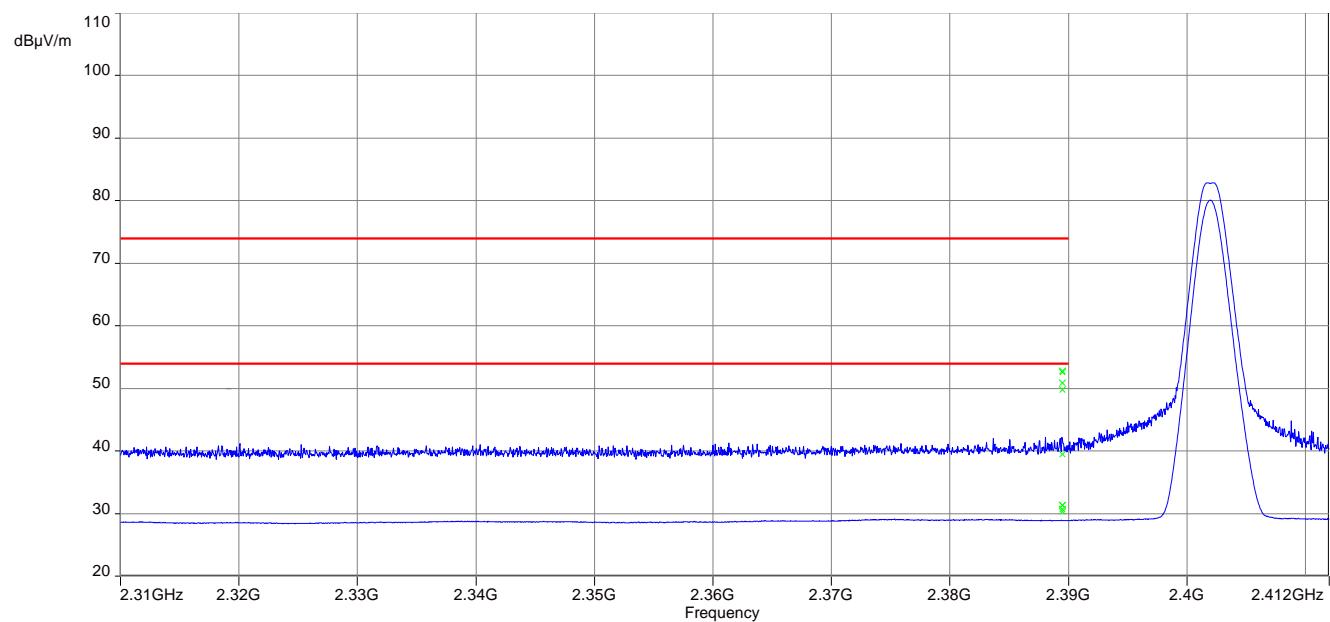
FCC	IC
Band edge compliance radiated	
<p>In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 5.205(c)).</p>	
	54 dB μ V/m AVG 74 dB μ V/m Peak

Result:

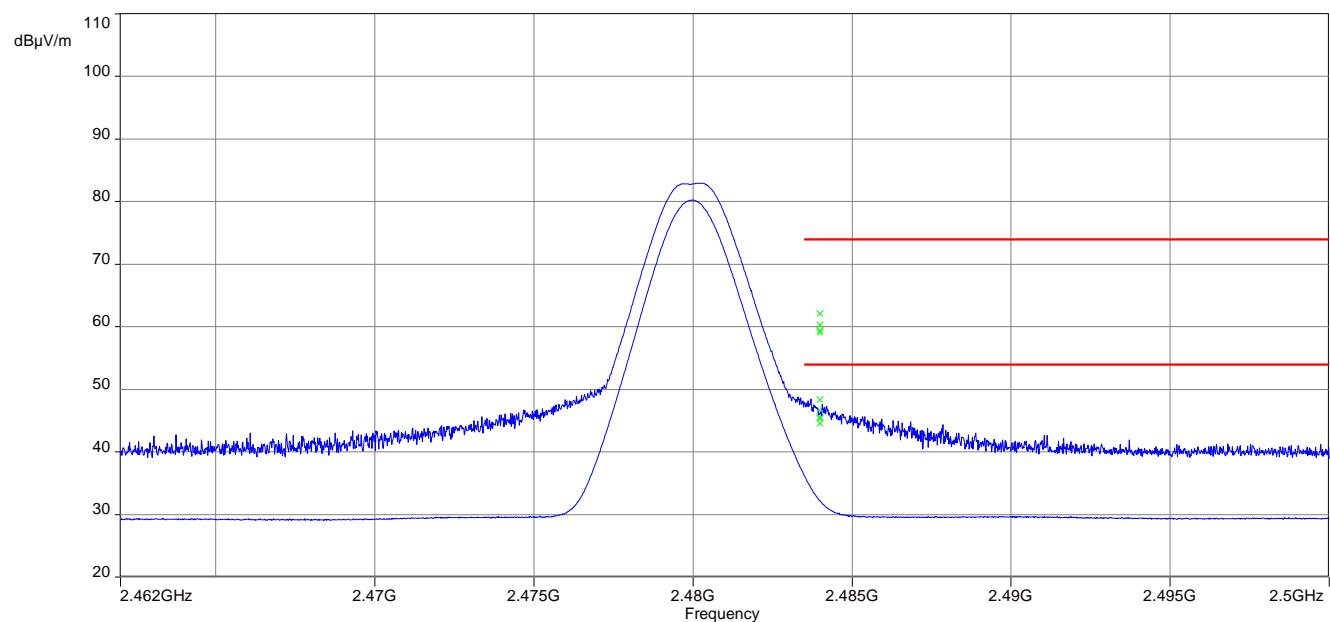
Scenario	Band edge compliance radiated [dB μ V/m]
	GFSK
Modulation	< 54 AVG / < 74 PP
Lower restricted band	< 54 AVG / < 74 PP
Upper restricted band	< 54 AVG / < 74 PP

Plots:

Plot 1: Lower restricted band



Plot 2: Upper restricted band



11.7 TX spurious emissions conducted

Description:

Measurement of the conducted spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit frequencies are 2402 MHz, 2440 MHz and 2480 MHz.

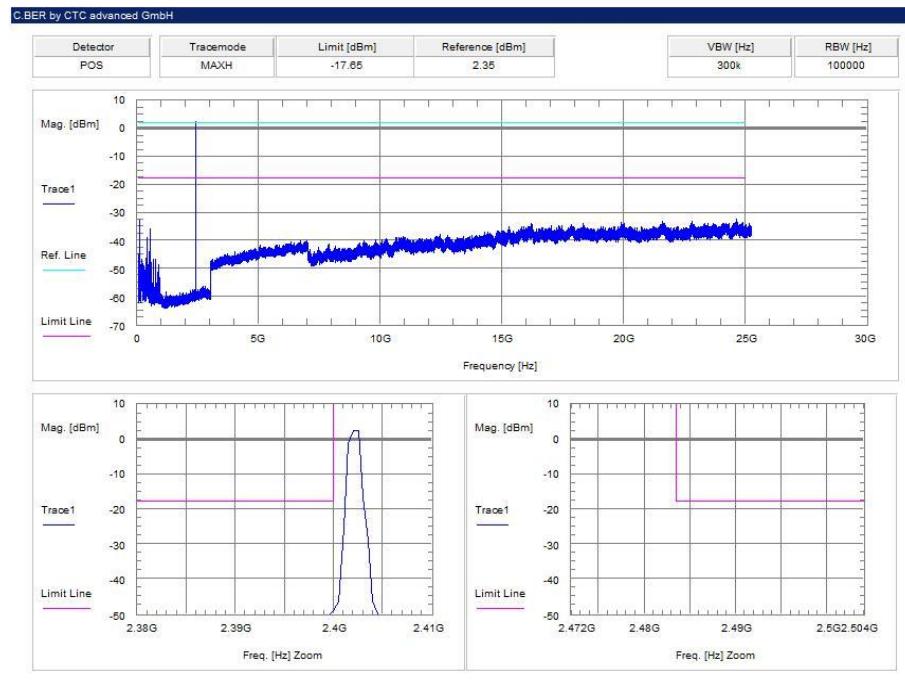
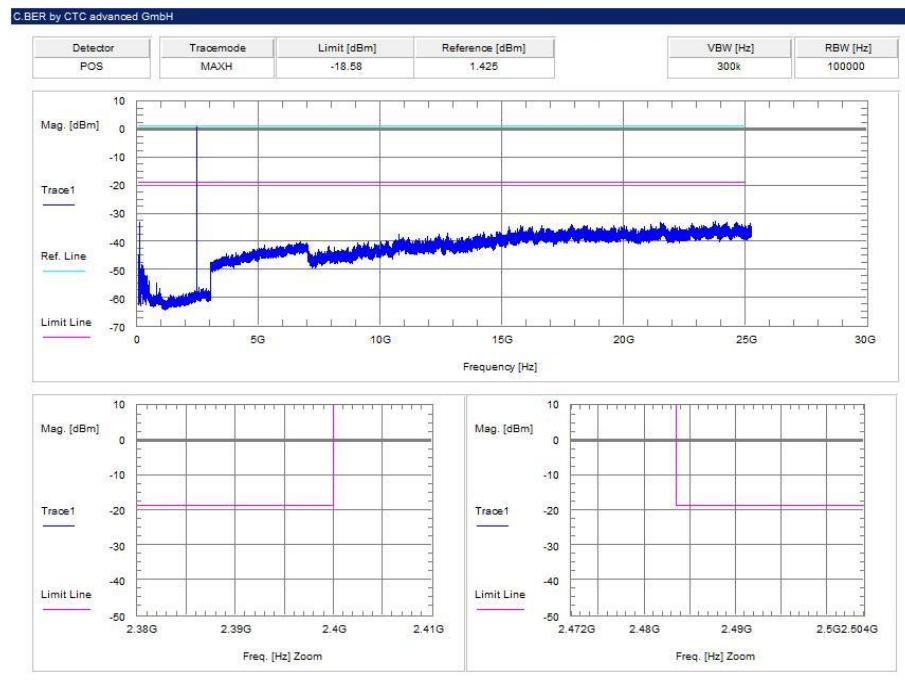
Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz or 500 kHz
Span	9 kHz to 25 GHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

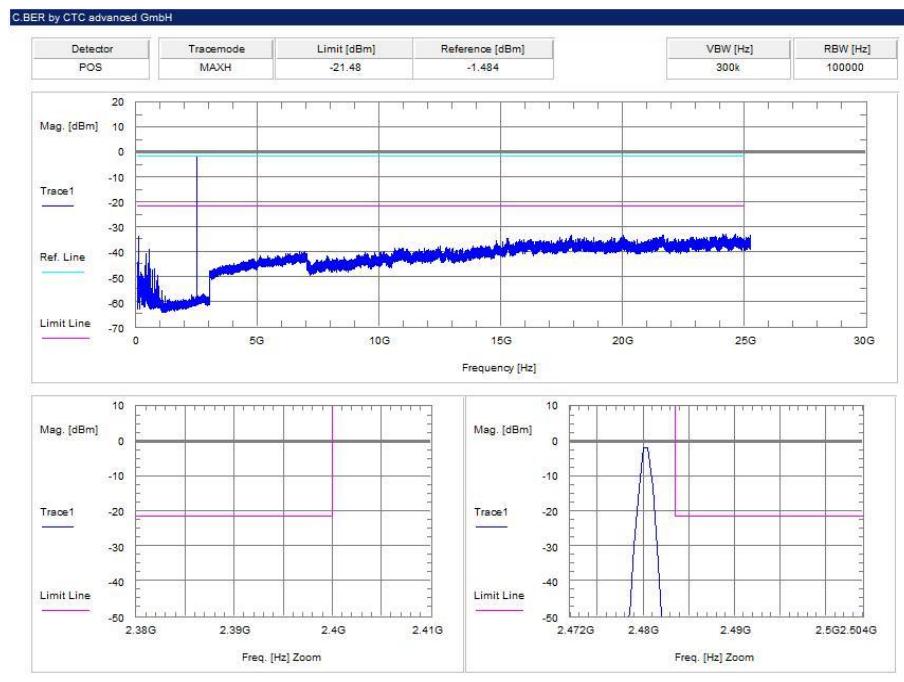
Limits:

FCC	IC
TX spurious emissions conducted	
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required	

Results:

TX spurious emissions conducted					
f [MHz]		amplitude of emission [dBm]	limit max. allowed emission power	actual attenuation below frequency of operation [dB]	results
2402		2.4	30 dBm		Operating frequency
All detected emissions are compliant with the -20 dBc limit!			-20 dBc		compliant
2440		1.4	30 dBm		Operating frequency
All detected emissions are compliant with the -20 dBc limit!			-20 dBc		compliant
2480		-1.5	30 dBm		Operating frequency
All detected emissions are compliant with the -20 dBc limit!			-20 dBc		compliant

Plots:**Plot 1: lowest channel****Plot 2: mid channel**

Plot 3: highest channel

11.8 Spurious emissions radiated below 30 MHz

Description:

Measurement of the radiated spurious emissions in transmit mode below 30 MHz. The EUT is set to single channel mode and the transmit frequencies are 2402 MHz, 2440 MHz and 2480 MHz. The measurement is performed in the mode with the highest output power. The limits are recalculated to a measurement distance of 3 m according the ANSI C63.10.

Measurement parameters	
Detector	Peak / Quasi peak
Sweep time	Auto
Resolution bandwidth	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth	F < 150 kHz: 1 kHz F > 150 kHz: 30 kHz
Span	9 kHz to 30 MHz
Trace mode	Max hold
Test setup	See sub clause 6.2 C
Measurement uncertainty	See sub clause 8

Limits:

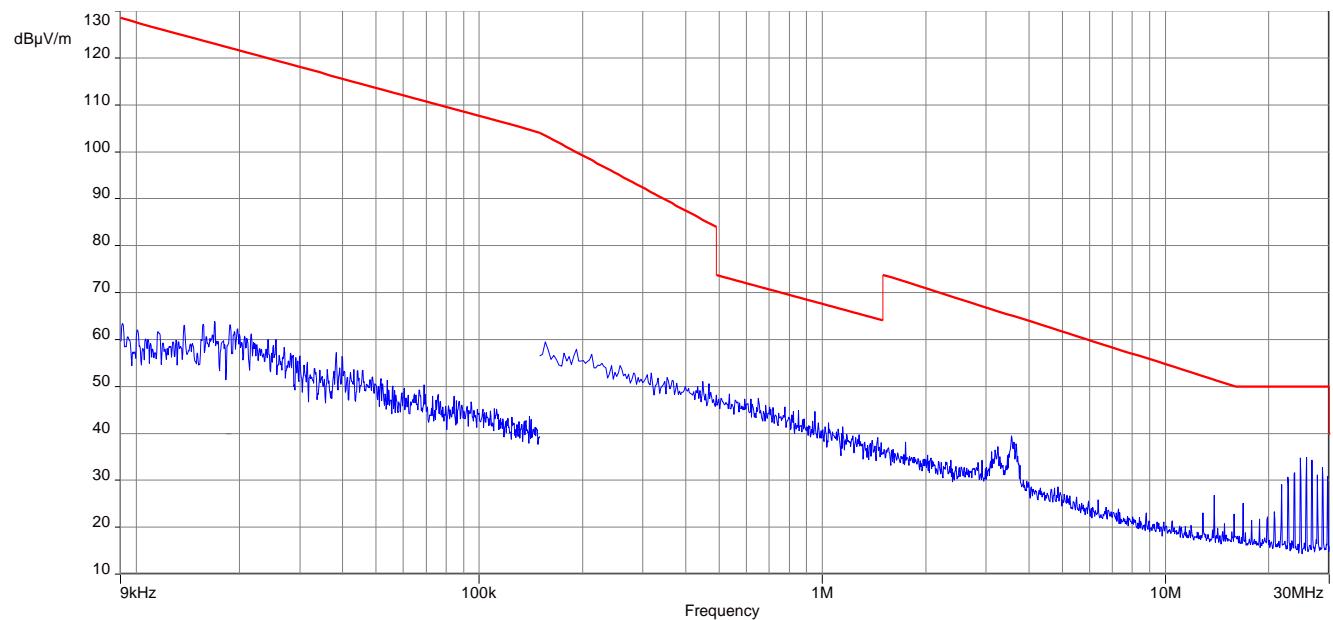
FCC	IC	
TX spurious emissions radiated below 30 MHz		
Frequency (MHz)	Field strength (dB μ V/m)	Measurement distance
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30.0	30	30

Results:

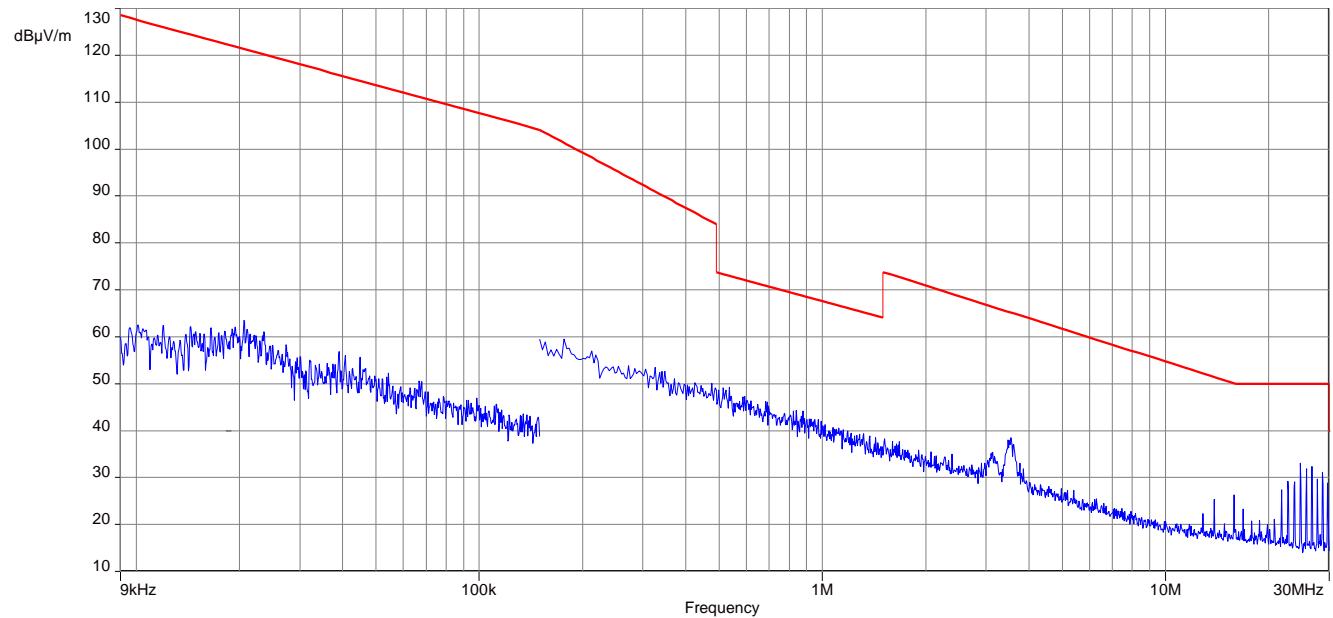
TX spurious emissions radiated below 30 MHz [dB μ V/m]		
F [MHz]	Detector	Level [dB μ V/m]
All detected emissions are more than 20 dB below the limit.		

Plots:

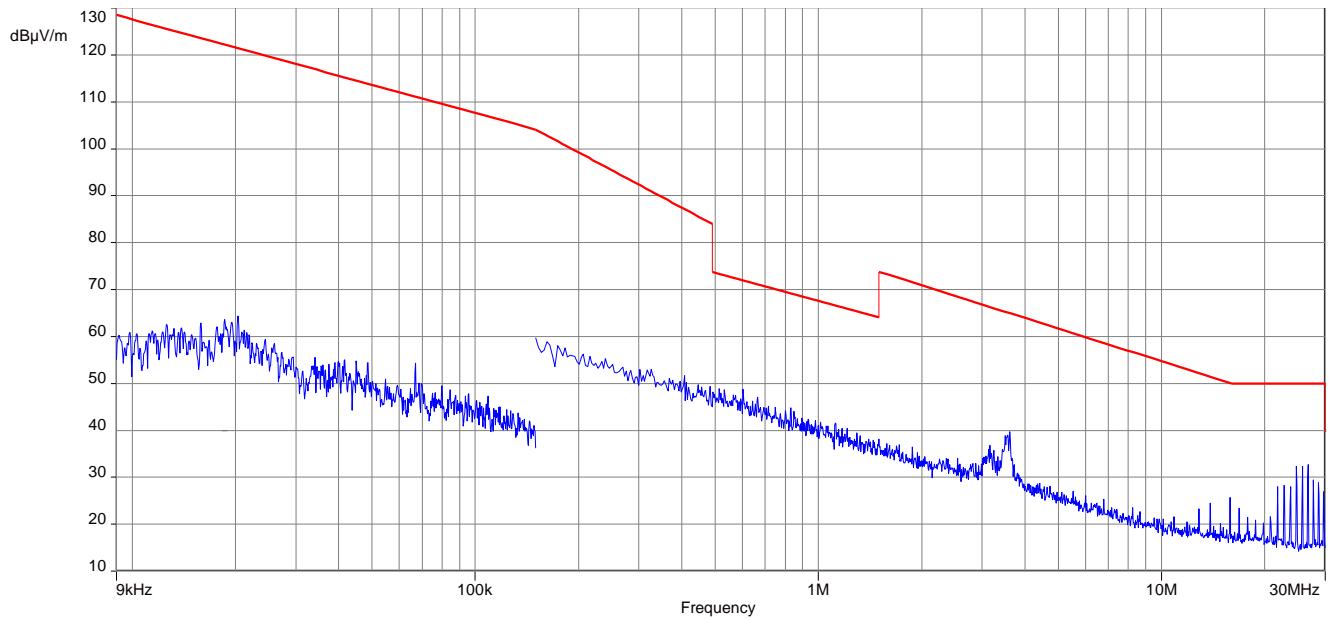
Plot 1: 9 kHz to 30 MHz, 2402 MHz, transmit mode



Plot 2: 9 kHz to 30 MHz, 2440 MHz, transmit mode



Plot 3: 9 kHz to 30 MHz, 2480 MHz, transmit mode



11.9 Spurious emissions radiated 30 MHz to 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit frequencies are 2402 MHz, 2440 MHz and 2480 MHz. The measurement is performed in the mode with the highest output power.

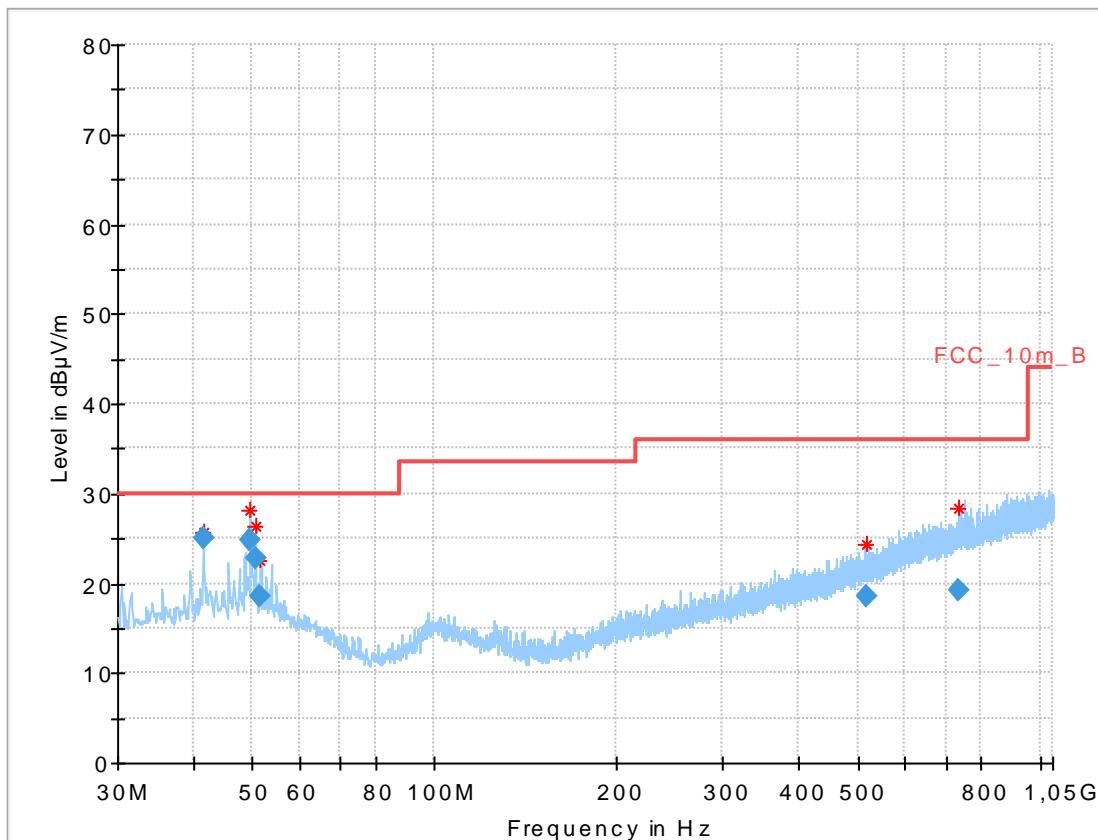
Measurement parameters	
Detector	Peak / Quasi Peak
Sweep time	Auto
Resolution bandwidth	120 kHz
Video bandwidth	3 x RBW
Span	30 MHz to 1 GHz
Trace mode	Max hold
Measured modulation	GFSK
Test setup	See sub clause 6.1 A
Measurement uncertainty	See sub clause 8

The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

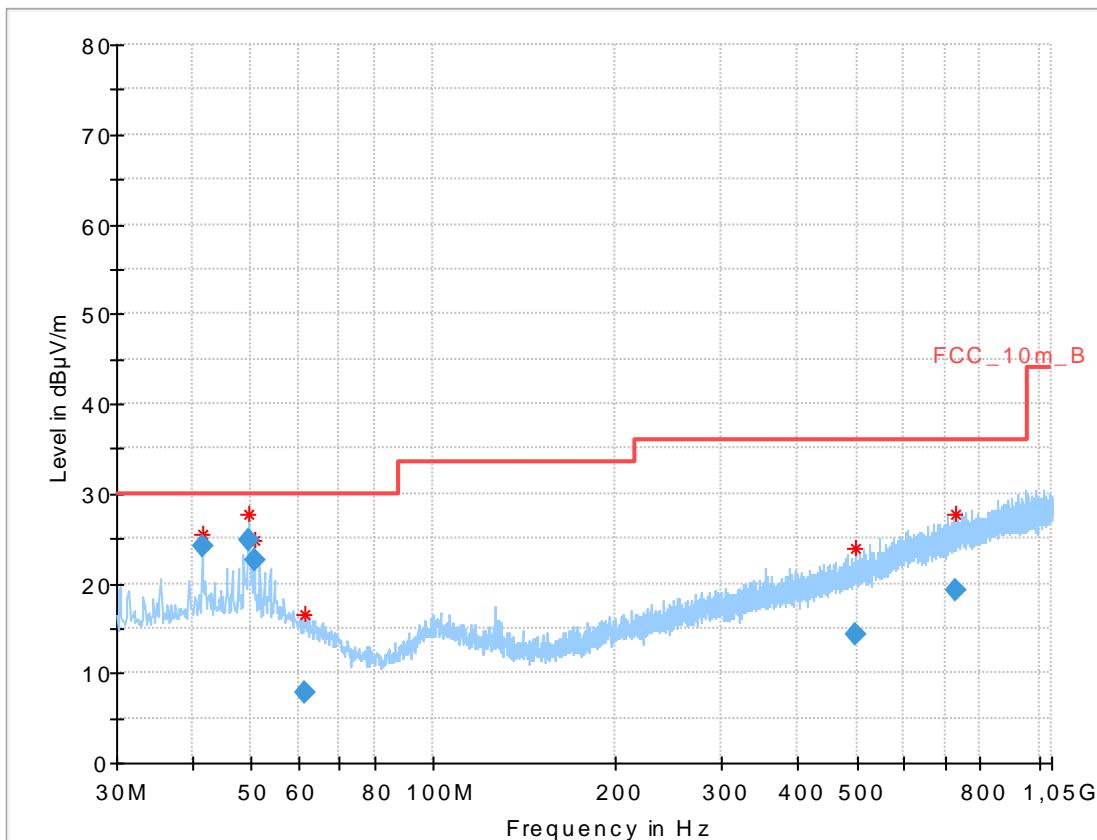
FCC	IC															
TX spurious emissions radiated																
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).																
§15.209																
<table border="1"> <thead> <tr> <th>Frequency (MHz)</th> <th>Field strength (dBμV/m)</th> <th>Measurement distance</th> </tr> </thead> <tbody> <tr> <td>30 - 88</td> <td>30.0</td> <td>10</td> </tr> <tr> <td>88 - 216</td> <td>33.5</td> <td>10</td> </tr> <tr> <td>216 - 960</td> <td>36.0</td> <td>10</td> </tr> <tr> <td>Above 960</td> <td>54.0</td> <td>3</td> </tr> </tbody> </table>		Frequency (MHz)	Field strength (dB μ V/m)	Measurement distance	30 - 88	30.0	10	88 - 216	33.5	10	216 - 960	36.0	10	Above 960	54.0	3
Frequency (MHz)	Field strength (dB μ V/m)	Measurement distance														
30 - 88	30.0	10														
88 - 216	33.5	10														
216 - 960	36.0	10														
Above 960	54.0	3														

Plots: Transmit mode

Plot 1: 30 MHz to 1 GHz, TX mode, 2402 MHz, vertical & horizontal polarization

Final results:

Frequency (MHz)	QuasiPeak (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
41.581800	24.94	30.00	5.06	1000.0	120.000	98.0	V	10.0	13.3
49.687350	24.72	30.00	5.28	1000.0	120.000	179.0	V	56.0	13.7
50.640600	22.71	30.00	7.29	1000.0	120.000	98.0	V	308.0	13.6
51.687150	18.58	30.00	11.42	1000.0	120.000	98.0	V	74.0	13.5
515.407950	18.44	36.00	17.56	1000.0	120.000	101.0	H	234.0	18.9
732.914550	19.16	36.00	16.84	1000.0	120.000	185.0	V	10.0	22.3

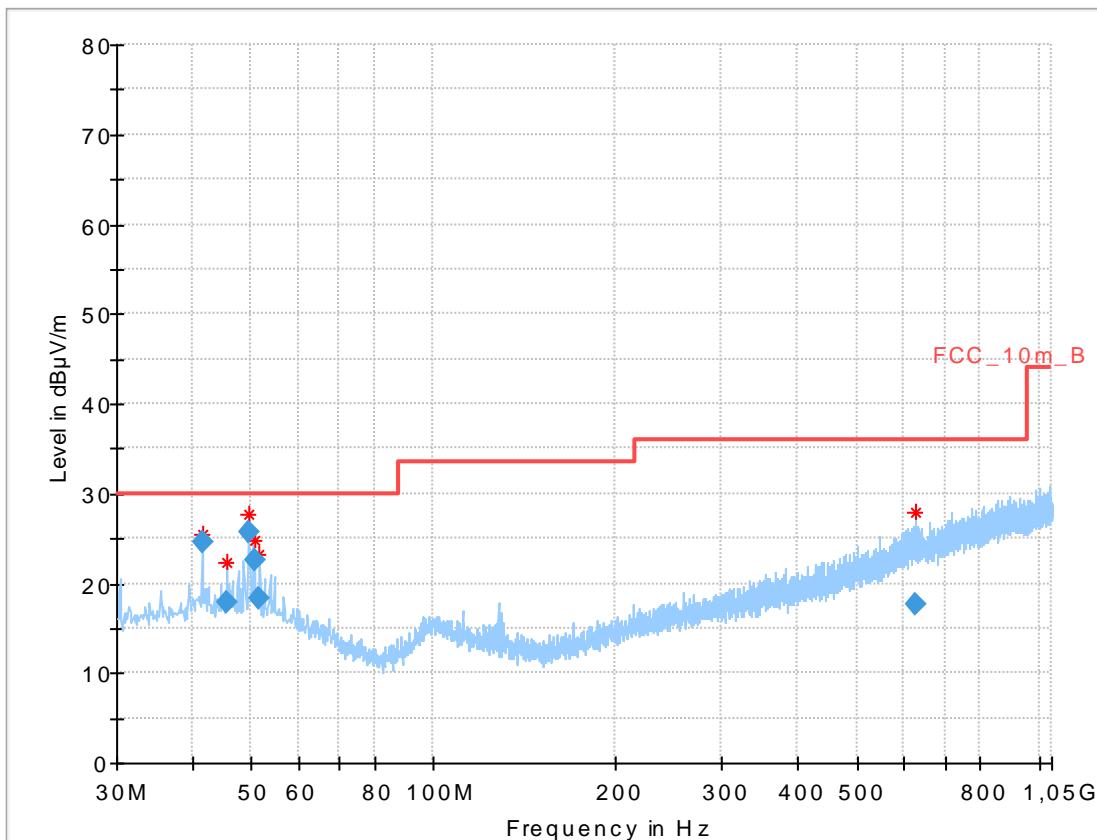
Plot 2: 30 MHz to 1 GHz, TX mode, 2440 MHz, vertical & horizontal polarization



Final results:

Frequency (MHz)	QuasiPeak (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
41.564250	24.18	30.00	5.82	1000.0	120.000	101.0	V	298.0	13.3
49.672500	24.83	30.00	5.17	1000.0	120.000	98.0	V	28.0	13.7
50.645700	22.59	30.00	7.41	1000.0	120.000	178.0	V	219.0	13.6
61.556400	7.76	30.00	22.24	1000.0	120.000	185.0	H	298.0	11.5
496.534050	14.35	36.00	21.65	1000.0	120.000	98.0	H	304.0	18.6
729.166950	19.14	36.00	16.86	1000.0	120.000	185.0	V	202.0	22.2

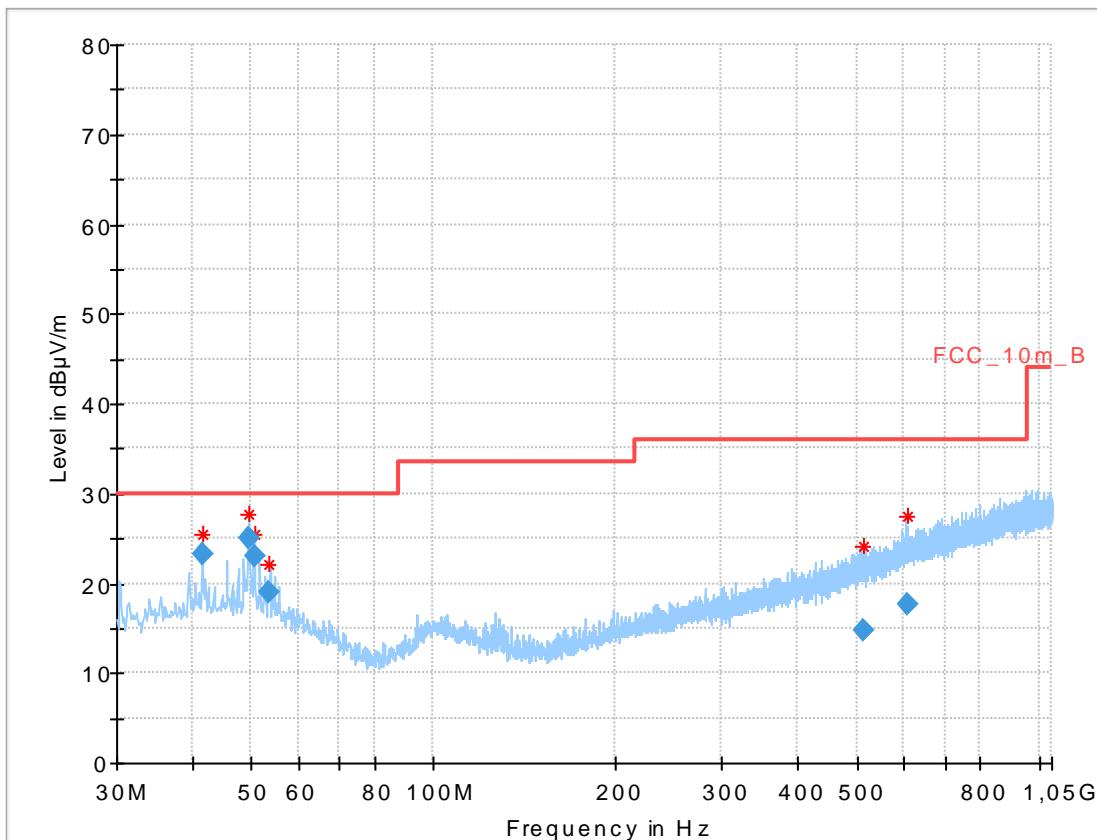
Plot 3: 30 MHz to 1 GHz, TX mode, 2480 MHz, vertical & horizontal polarization



Final results:

Frequency (MHz)	QuasiPeak (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
41.513100	24.57	30.00	5.43	1000.0	120.000	98.0	V	351.0	13.3
45.641550	17.83	30.00	12.17	1000.0	120.000	98.0	V	327.0	13.6
49.648350	25.61	30.00	4.39	1000.0	120.000	98.0	V	309.0	13.7
50.668350	22.65	30.00	7.35	1000.0	120.000	98.0	V	255.0	13.6
51.630450	18.40	30.00	11.60	1000.0	120.000	98.0	V	215.0	13.5
627.182100	17.69	36.00	18.31	1000.0	120.000	101.0	H	54.0	20.9

Plots: Receiver mode

Plot 1: 30 MHz to 1 GHz, RX / idle – mode, vertical & horizontal polarization

Final results:

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
41.518200	23.32	30.00	6.68	1000.0	120.000	178.0	V	253.0	13.3
49.587900	24.99	30.00	5.01	1000.0	120.000	98.0	V	223.0	13.7
50.618250	22.95	30.00	7.05	1000.0	120.000	98.0	V	123.0	13.7
53.688150	18.95	30.00	11.05	1000.0	120.000	178.0	V	35.0	13.3
514.724850	14.71	36.00	21.29	1000.0	120.000	185.0	H	253.0	18.9
604.951950	17.64	36.00	18.36	1000.0	120.000	185.0	V	71.0	20.8

11.10 Spurious emissions radiated above 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit frequencies are 2402 MHz, 2440 MHz and 2480 MHz. The measurement is performed in the mode with the highest output power.

Measurement parameters	
Detector	Peak / RMS
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 x RBW
Span	1 GHz to 26 GHz
Trace mode	Max hold
Measured modulation	GFSK
Test setup	See sub clause 6.2 A (1 GHz - 18 GHz) See sub clause 6.3 A (18 GHz - 26 GHz)
Measurement uncertainty	See sub clause 8

The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

FCC	IC	
TX spurious emissions radiated		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an R F conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
§15.209		
Frequency (MHz)	Field strength (dB μ V/m)	Measurement distance
Above 960	54.0 (Average)	3
Above 960	74.0 (Peak)	3

Results: Transmitter mode

TX spurious emissions radiated [dB μ V/m]								
2402 MHz			2440 MHz			2480 MHz		
F [MHz]	Detector	Level [dB μ V/m]	F [MHz]	Detector	Level [dB μ V/m]	F [MHz]	Detector	Level [dB μ V/m]
4804	Peak	52.2	7320	Peak	54.2	7440	Peak	54.2
	AVG	35.7*		AVG	37.7*		AVG	37.7*
	Peak			Peak			Peak	
	AVG			AVG			AVG	
	Peak			Peak			Peak	
	AVG			AVG			AVG	

*) Average emission adjusting factor:

$$F = 20 * \log (\text{dwell time}^* / 100 \text{ ms})$$

*with TXon time as dwell time!

Bluetooth LE connected mode: Duty Cycle correction Scenarios

TX payload bytes	TX dwell time [ms]	TXon time [ms]	RX dwell time min [ms]	No of TX within 100 ms 100ms/(TxDwell +RxDwell)	min no of hopping channels (AFH)	max TX time [ms]/channel within 100ms	DC correction F [dB]	Scenario
37	0.625	0.376	0.625	80.0	2	15	-16.46	TX Packet. Rx =ACK
37	0.625	0.376	0.625	80.0	2	15	-16.46	TX Packet = RX Packet

Note: For BT LE the dwell time is a multiple of 0.625ms

Bluetooth LE Advertising mode:

Advertising is always in none Hopping mode.

A Bluetooth LE packet in advertising mode consists of:

Preamble (1 Byte)

Access Address (4 Bytes):always: 0x8E89BED6

PDU Header (2 Bytes)

PDU MAC address (6 Bytes)

PDU Data (0-31 Bytes) (connected undirected advertising (ADV_IND)

CRC (3 Bytes)

The maximum size of a complete advertising packet is 47 Bytes (376us)

Minimum possible advertising interval (per advertising channel): 20 ms

Duty cycle within 100ms: $5 * 0.376 \text{ms} / 100 \text{ms} = 0.0188 = 1.88\%$

Correction factor for average calculation:

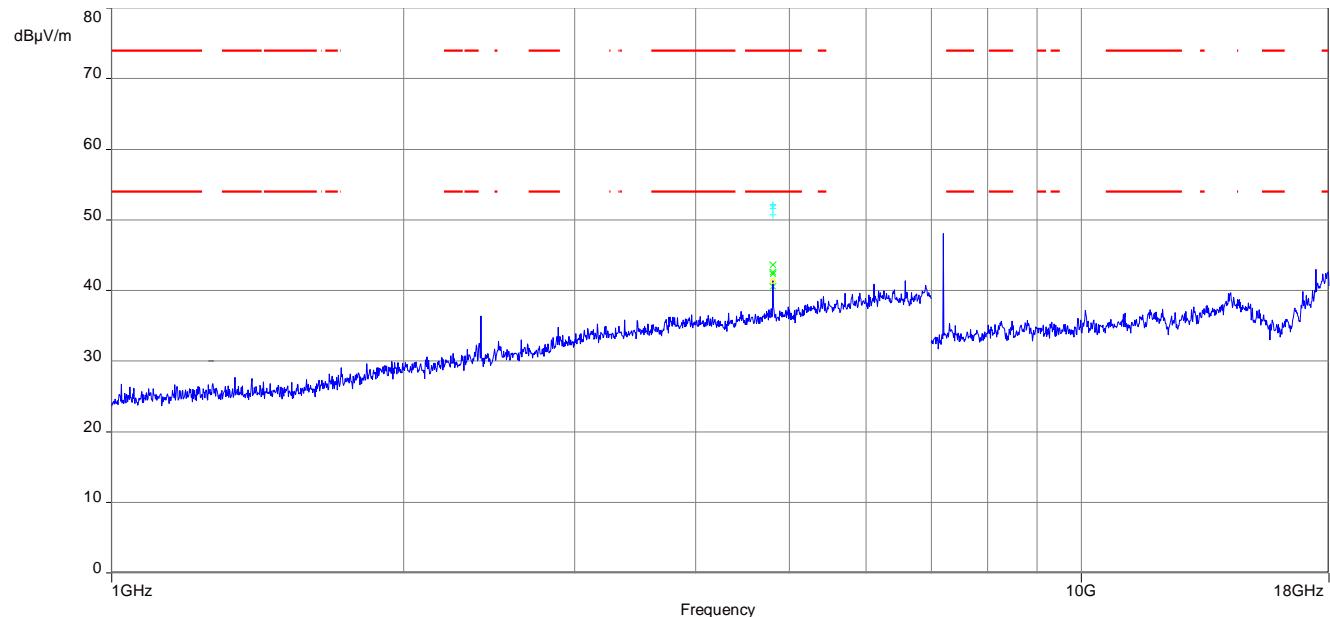
$$F = 20 * \log (0.0188) = -34.51 \text{dB}$$

Results: Receiver mode

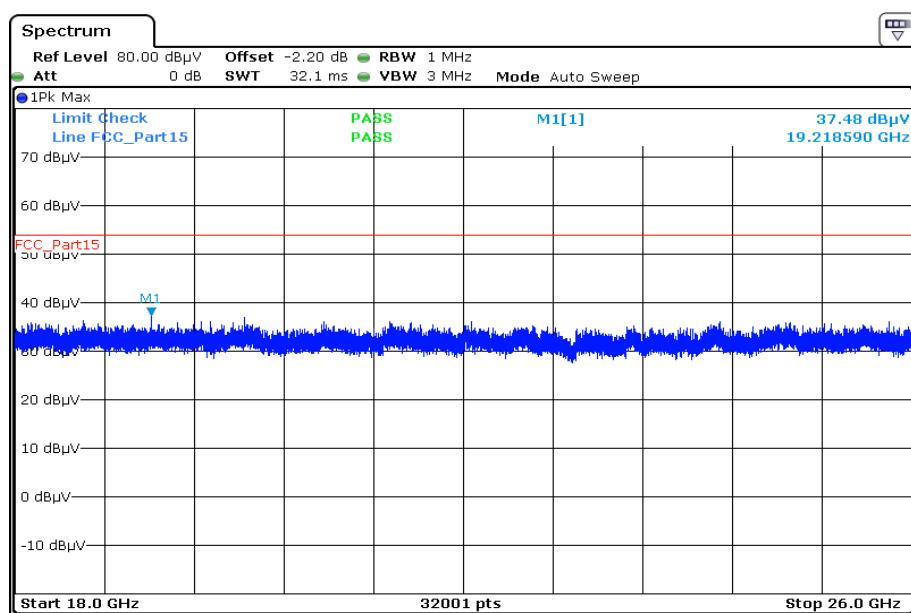
RX spurious emissions radiated [dB μ V/m]		
F [MHz]	Detector	Level [dB μ V/m]
All detected emissions are more than 20 dB below the limit.		
	Peak	
	AVG	

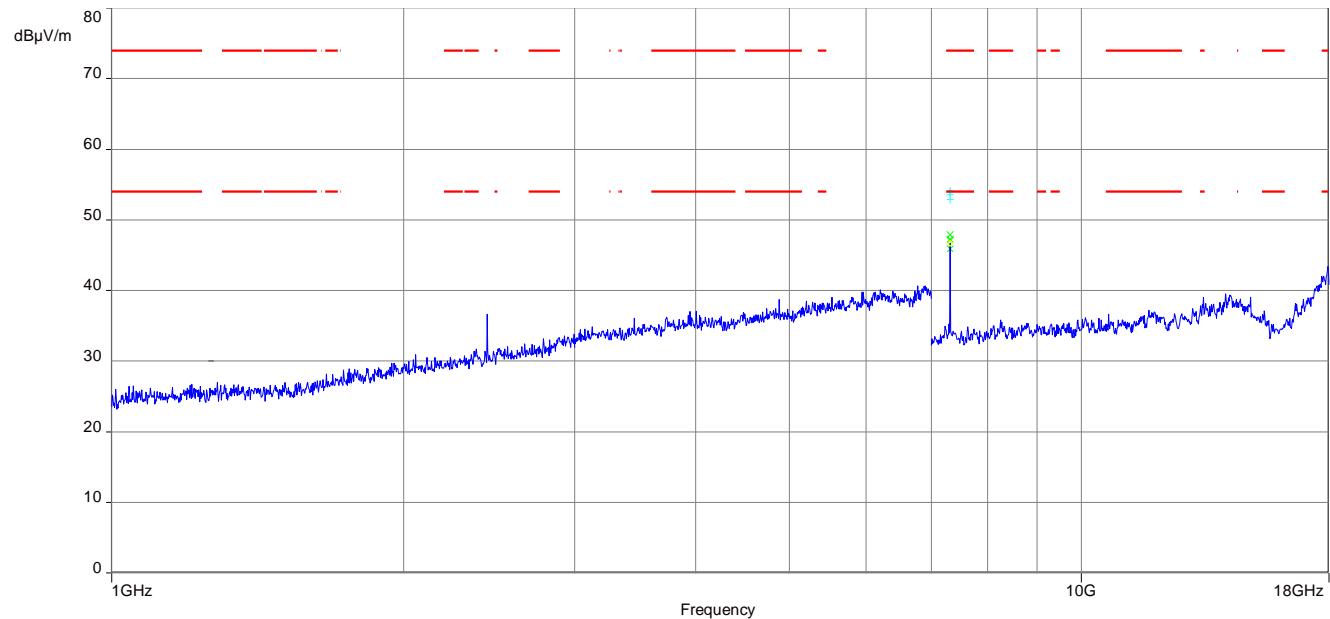
Note: The limit was recalculated with 20 dB / decade (Part 15.31) for all radiated spurious emissions 30 MHz to 1 GHz from 3 meter limit to a 10 meter distance. (40dB/decade for emissions < 30MHz)

Plots: Transmitter mode

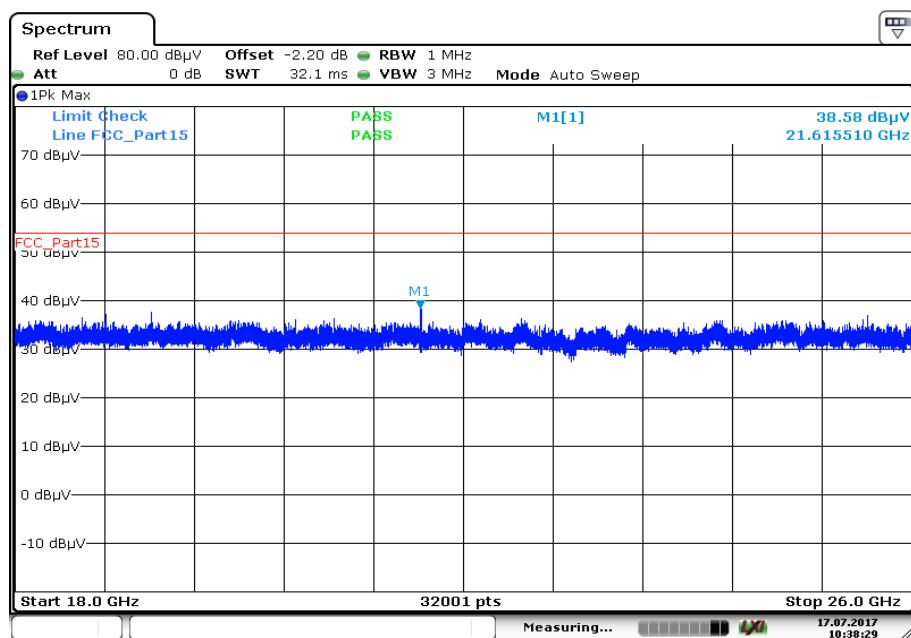
Plot 1: 1 GHz to 18 GHz, TX mode, 2402 MHz, vertical & horizontal polarization


The carrier signal is notched with a 2.4 GHz band rejection filter.

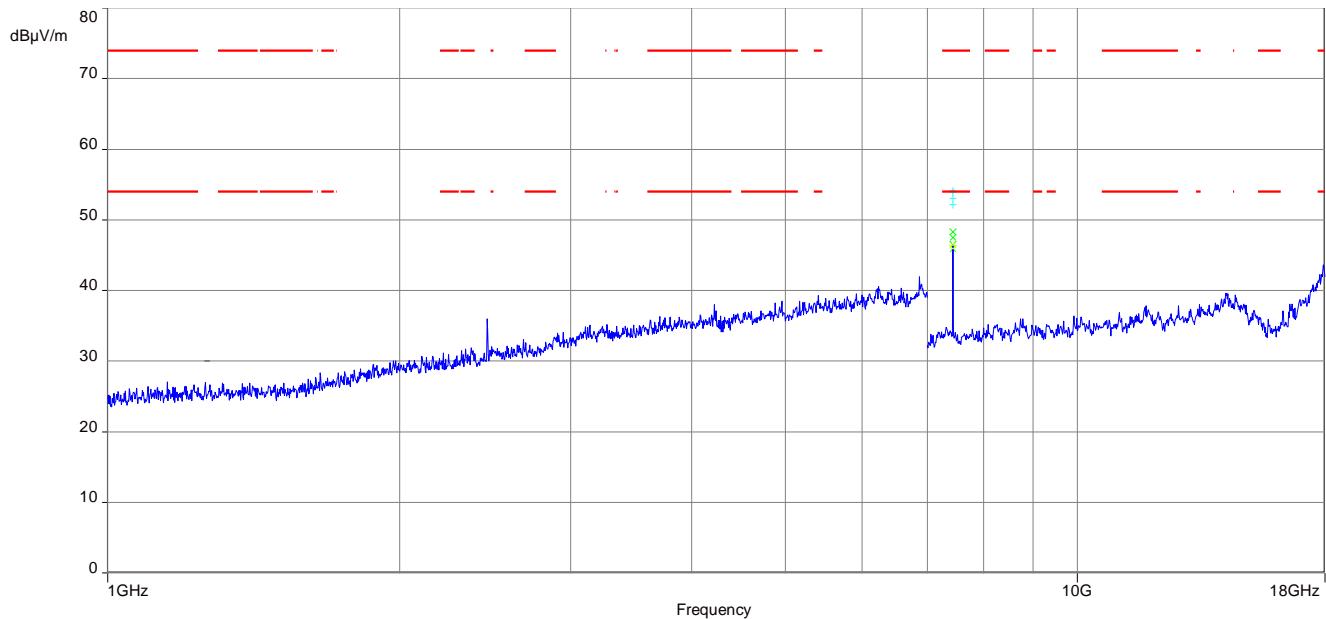
Plot 2: 18 GHz to 26 GHz, TX mode, 2402 MHz, vertical & horizontal polarization


Plot 3: 1 GHz to 18 GHz, TX mode, 2440 MHz, vertical & horizontal polarization

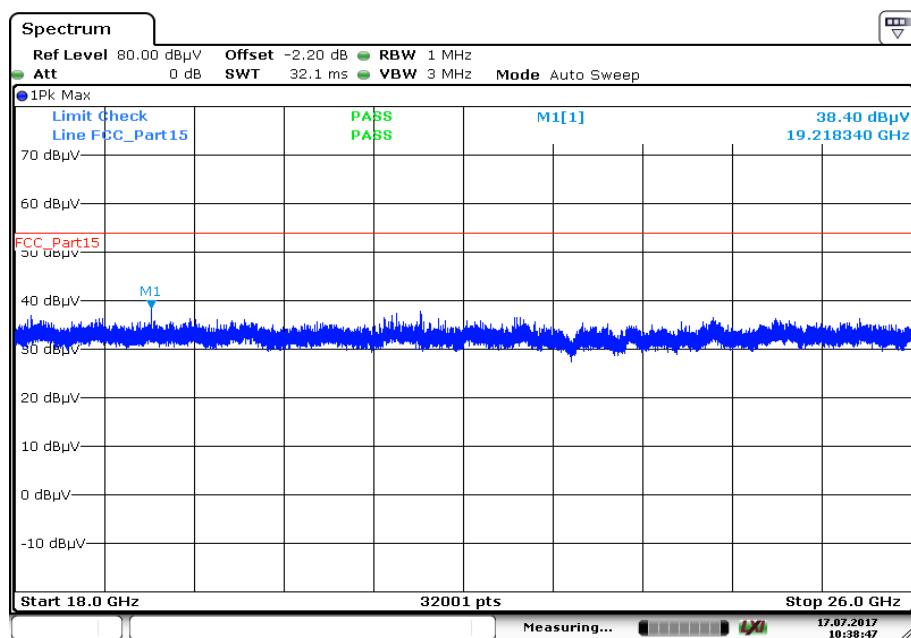
The carrier signal is notched with a 2.4 GHz band rejection filter.

Plot 4: 18 GHz to 26 GHz, TX mode, 2440 MHz, vertical & horizontal polarization

Date: 17.JUL.2017 10:38:29

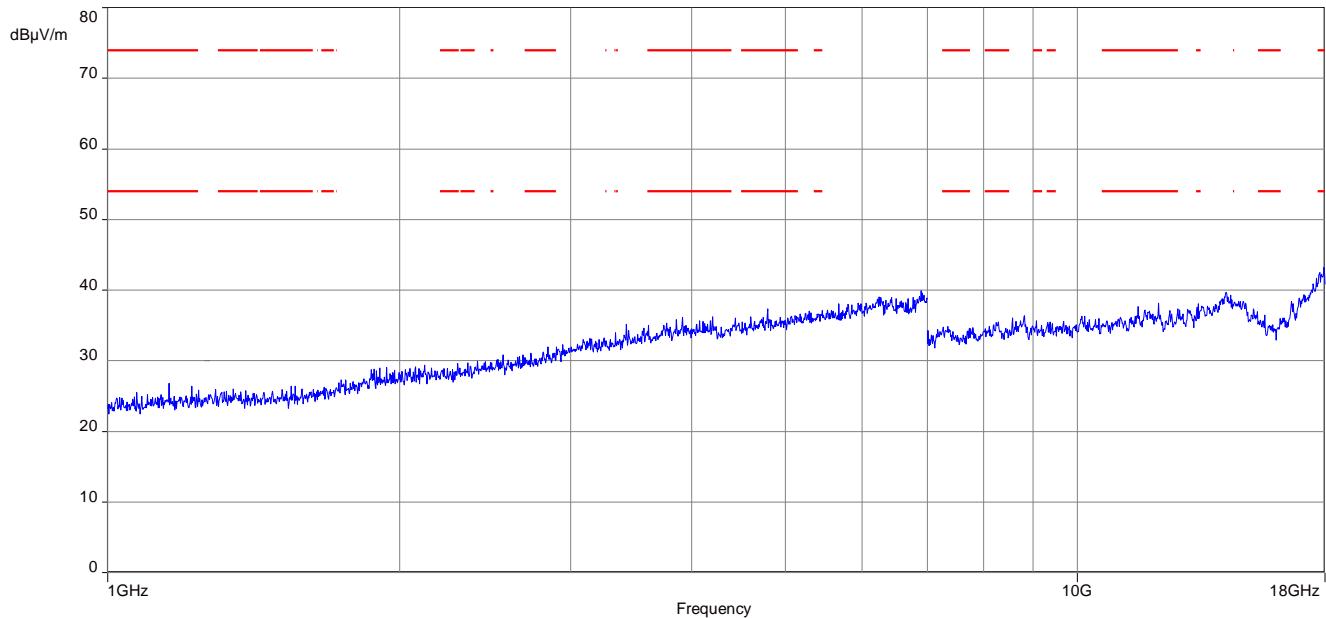
Plot 5: 1 GHz to 18 GHz, TX mode, 2480 MHz, vertical & horizontal polarization

The carrier signal is notched with a 2.4 GHz band rejection filter.

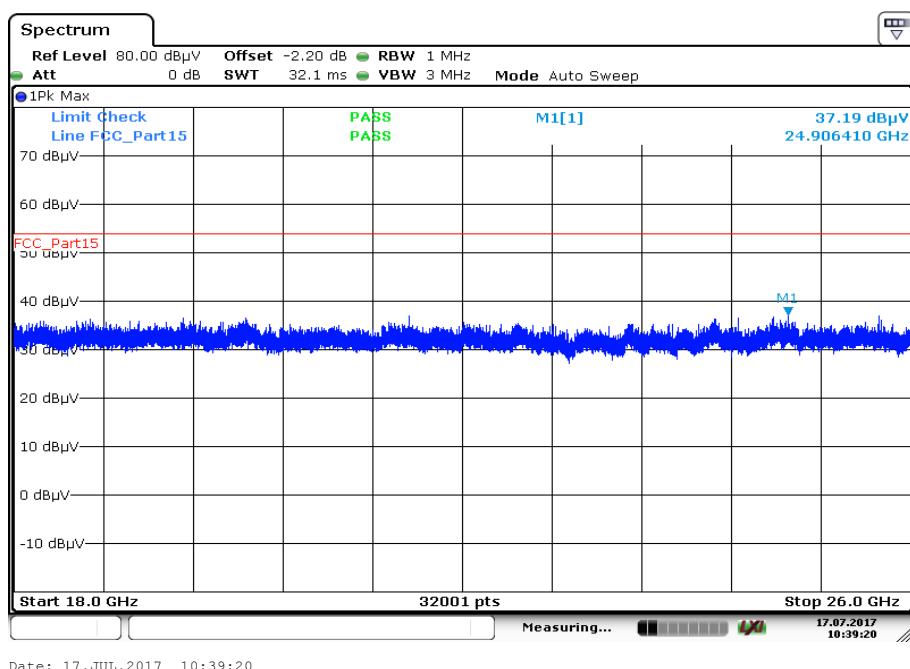
Plot 6: 18 GHz to 26 GHz, TX mode, 2480 MHz, vertical & horizontal polarization

Plots: Receiver mode

Plot 1: 1 GHz to 18 GHz, RX / idle – mode, vertical & horizontal polarization



Plot 2: 18 GHz to 26 GHz, RX / idle – mode, vertical & horizontal polarization



11.11 Spurious emissions conducted below 30 MHz (AC conducted)

Description:

Measurement of the conducted spurious emissions in transmit mode below 30 MHz. The EUT is set to single channel mode and the transmit frequency is 2440 MHz. This measurement is representative for all channels and modes. If critical peaks are found frequency 2402 MHz and 2480 MHz will be measured too. The measurement is performed in the mode with the highest output power. Both power lines, phase and neutral line, are measured. Found peaks are remeasured with average and quasi peak detection to show compliance to the limits.

Measurement parameters	
Detector	Peak - Quasi peak / average
Sweep time	Auto
Resolution bandwidth	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span:	9 kHz to 30 MHz
Trace mode:	Max hold
Test setup	See sub clause 6.5. A
Measurement uncertainty	See sub clause 8

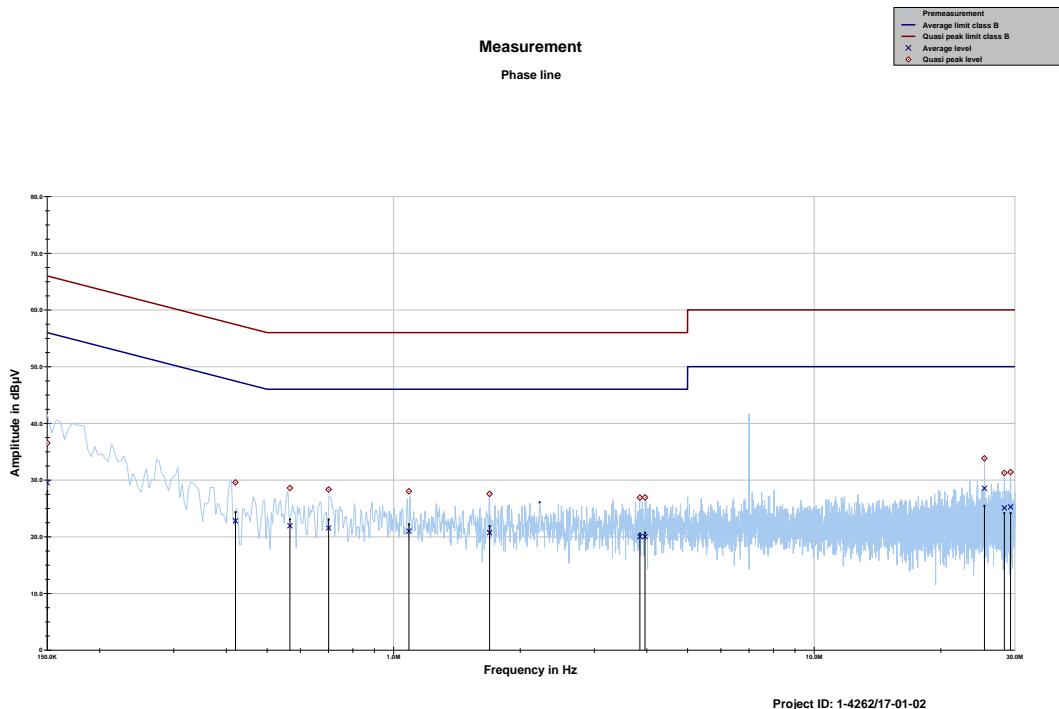
Limits:

FCC	IC	
TX spurious emissions conducted < 30 MHz		
Frequency (MHz)	Quasi-peak (dB μ V/m)	Average (dB μ V/m)
0.15 – 0.5	66 to 56*	56 to 46*
0.5 – 5	56	46
5 – 30.0	60	50

*Decreases with the logarithm of the frequency

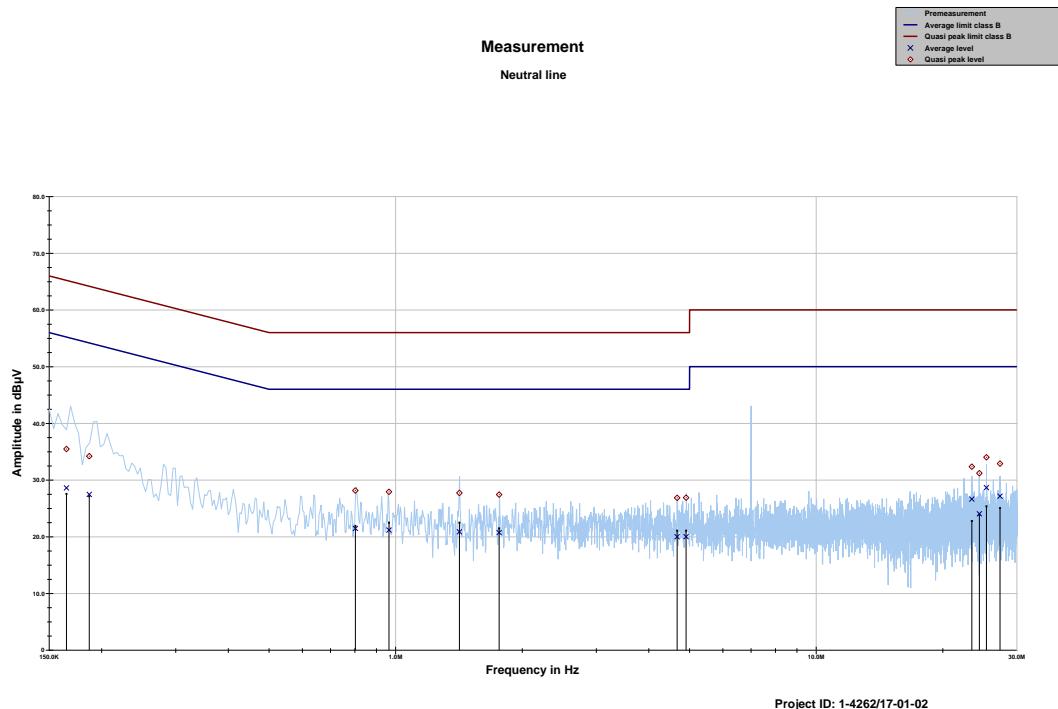
Results:

Spurious emissions conducted < 30 MHz [dB μ V/m]		
F [MHz]	Detector	Level [dB μ V/m]
No emissions detected		

Plots:**Plot 1:** 150 kHz to 30 MHz, phase line**Final results:**

Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dB μ V	dB	dB μ V	dB μ V	dB	dB μ V
0.150138	36.52	29.48	65.992	29.53	26.47	55.996
0.420655	29.58	27.85	57.435	22.80	25.47	48.267
0.566734	28.60	27.40	56.000	21.92	24.08	46.000
0.700754	28.34	27.66	56.000	21.54	24.46	46.000
1.087774	28.03	27.97	56.000	21.00	25.00	46.000
1.691421	27.56	28.44	56.000	20.71	25.29	46.000
3.850768	26.91	29.09	56.000	20.04	25.96	46.000
3.961388	26.93	29.07	56.000	20.03	25.97	46.000
25.404571	33.82	26.18	60.000	28.54	21.46	50.000
28.332663	31.26	28.74	60.000	25.08	24.92	50.000
29.312994	31.40	28.60	60.000	25.27	24.73	50.000

Plot 2: 150 kHz to 30 MHz, neutral line



Final results:

Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dB μ V	dB	dB μ V	dB μ V	dB	dB μ V
0.164947	35.47	29.74	65.211	28.61	26.96	55.573
0.186836	34.21	29.97	64.176	27.46	27.48	54.948
0.802339	28.15	27.85	56.000	21.45	24.55	46.000
0.964551	27.92	28.08	56.000	21.17	24.83	46.000
1.418156	27.73	28.27	56.000	20.87	25.13	46.000
1.762397	27.44	28.56	56.000	20.74	25.26	46.000
4.670200	26.85	29.15	56.000	19.99	26.01	46.000
4.906352	26.88	29.12	56.000	20.01	25.99	46.000
23.454260	32.35	27.65	60.000	26.65	23.35	50.000
24.441112	31.21	28.79	60.000	24.05	25.95	50.000
25.407304	34.01	25.99	60.000	28.66	21.34	50.000
27.360751	32.89	27.11	60.000	27.15	22.85	50.000

12 Observations

No observations except those reported with the single test cases have been made.

Annex A Glossary

EUT	Equipment under test
DUT	Device under test
UUT	Unit under test
ETSI	European Telecommunications Standard Institute
EN	European Standard
FCC	Federal Communication Commission
FCC ID	Company Identifier at FCC
IC	Industry Canada
PMN	Product marketing name
HMN	Host marketing name
HVIN	Hardware version identification number
FVIN	Firmware version identification number
EMC	Electromagnetic Compatibility
HW	Hardware
SW	Software
Inv. No.	Inventory number
S/N or SN	Serial number
C	Compliant
NC	Not compliant
NA	Not applicable
NP	Not performed
PP	Positive peak
QP	Quasi peak
AVG	Average
OC	Operating channel
OCW	Operating channel bandwidth
OBW	Occupied bandwidth
OOB	Out of band
DFS	Dynamic frequency selection
CAC	Channel availability check
OP	Occupancy period
NOP	Non occupancy period
DC	Duty cycle
PER	Packet error rate
CW	Clean wave
MC	Modulated carrier
WLAN	Wireless local area network
RLAN	Radio local area network
DSSS	Dynamic sequence spread spectrum
OFDM	Orthogonal frequency division multiplexing
FHSS	Frequency hopping spread spectrum

Annex B Document history

Version	Applied changes	Date of release
-/-	Initial release	2017-08-08
A	HVIN and PMN changed	2017-11-29

Annex C Accreditation Certificate

first page	last page
 <p>Deutsche Akkreditierungsstelle GmbH Befähigte gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV Unterzeichnerin der Multilateralen Abkommen von EA, ILAC und IAF zur gegenseitigen Anerkennung</p> <p>Akkreditierung </p> <p>Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium CTC advanced GmbH Untertürkheimer Straße 6-10, 66117 Saarbrücken</p> <p>die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:</p> <p>Funk Mobilfunk (GSM / DCS) + OTA Elektromagnetische Verträglichkeit (EMV) Produktsicherheit SAR / EMF Umwelt Smart Card Technology Bluetooth® Automotive Wi-Fi-Services Kanadische Anforderungen US-Anforderungen Akustik Near Field Communication (NFC)</p> <p>Die Akkreditierungsurkunde gilt nur in Verbindung mit dem Bescheid vom 25.11.2016 mit der Akkreditierungsnummer D-PL-12076-01, und ist gültig bis 17.01.2018. Sie besteht aus diesem Deckblatt, der Rückseite des Deckblatts und der folgenden Anlage mit insgesamt 63 Seiten.</p> <p>Registrierungsnummer der Urkunde: D-PL-12076-01-01</p> <p>Frankfurt, 25.11.2016 Seite Hinweise auf der Rückseite</p> <p>Im Auftrag Dipl.-Ing. (FH) Ralf Egner Abteilungsleiter</p>	<p>Deutsche Akkreditierungsstelle GmbH</p> <p>Standort Berlin Spittelmarkt 10 10117 Berlin</p> <p>Standort Frankfurt am Main Europa-Allee 52 60327 Frankfurt am Main</p> <p>Standort Braunschweig Bundesallee 100 38116 Braunschweig</p> <p>Die auszugsweise Veröffentlichung der Akkreditierungsurkunde bedarf der vorherigen schriftlichen Zustimmung der Deutsche Akkreditierungsstelle GmbH (DAkkS). Ausgenommen davon ist die separate Weiterverbreitung des Deckblattes durch die umseitig genannte Konformitätsbewertungsstelle in unveränderter Form.</p> <p>Es darf nicht der Anschein erweckt werden, dass sich die Akkreditierung auch auf Bereiche erstreckt, die über den durch die DAkkS bestätigten Akkreditierungsbereich hinausgehen.</p> <p>Die Akkreditierung erfolgte gemäß des Gesetzes über die Akkreditierungsstelle (AkkStelleG) vom 31. Juli 2009 (BGBl. I S. 2022) und der Verordnung (EG) Nr. 765/2008 des Europäischen Parlaments und des Rates vom 9. Juli 2008 über die Vorschriften für die Akkreditierung und Marktüberwachung im Zusammenhang mit der Vermarktung von Produkten (Abl. L 218 vom 9. Juli 2008, S. 30).</p> <p>Die DAkkS ist Unterzeichnerin der Multilateralen Abkommen zur gegenseitigen Anerkennung der European co-operation for Accreditation (EA), des International Accreditation Forum (IAF) und der International Laboratory Accreditation Cooperation (ILAC). Die Unterzeichner dieser Abkommen erkennen ihre Akkreditierungen gegenseitig an.</p> <p>Der aktuelle Stand der Mitgliedschaft kann folgenden Webseiten entnommen werden: EA: www.european-accreditation.org ILAC: www.ilac.org IAF: www.iaf.nu</p>

Note: The current certificate including annex is published on the website (link see below) of the Accreditation Body DAkkS or may be received by CTC advanced GmbH on request

<http://www.dakks.de/as/ast/d/D-PL-12076-01-01.pdf>

<http://www.dakks.de/as/ast/d/D-PL-12076-01-02.pdf>